

# LM7321x Single and LM7322x Dual Rail-to-Rail Input and Output $\pm 15$ -V, High-Output Current and Unlimited Capacitive Load Operational Amplifier

## 1 Features

- ( $V_S = \pm 15$ ,  $T_A = 25^\circ\text{C}$ , Typical Values Unless Specified.)
- Wide Supply Voltage Range 2.5 V to 32 V
- Output Current +65 mA/–100 mA
- Gain Bandwidth Product 20 MHz
- Slew Rate 18 V/ $\mu\text{s}$
- Capacitive Load Tolerance Unlimited
- Input Common-Mode Voltage 0.3-V Beyond Rails
- Input Voltage Noise 15 nV/ $\sqrt{\text{Hz}}$
- Input Current Noise 1.3 pA/ $\sqrt{\text{Hz}}$
- Supply Current/Channel 1.1 mA
- Distortion THD+Noise –86 dB
- Temperature Range  $-40^\circ\text{C}$  to  $125^\circ\text{C}$
- Tested at  $-40^\circ\text{C}$ ,  $25^\circ\text{C}$  and  $125^\circ\text{C}$  at 2.7 V,  $\pm 5$  V,  $\pm 15$  V.
- LM732xx are Automotive Grade Products that are AEC-Q100 Grade 1 Qualified.

## 2 Applications

- Driving MOSFETs and Power Transistors
- Capacitive Proximity Sensors
- Driving Analog Optocouplers
- High-Side Sensing
- Below Ground Current Sensing
- Photodiode Biasing
- Driving Varactor Diodes in PLLs
- Wide Voltage Range Power supplies
- Automotive
- International Power Supplies

## 3 Description

The LM732xx devices are rail-to-rail input and output amplifiers with wide operating voltages and high-output currents. The LM732xx family is efficient, achieving 18-V/ $\mu\text{s}$  slew rate and 20-MHz unity gain bandwidth while requiring only 1 mA of supply current per op amp. The LM732xx device performance is fully specified for operation at 2.7 V,  $\pm 5$  V and  $\pm 15$  V.

The LM732xx devices are designed to drive unlimited capacitive loads without oscillations. All LM7321x and LM7322x parts are tested at  $-40^\circ\text{C}$ ,  $125^\circ\text{C}$ , and  $25^\circ\text{C}$ , with modern automatic test equipment. High performance from  $-40^\circ\text{C}$  to  $125^\circ\text{C}$ , detailed specifications, and extensive testing makes them suitable for industrial, automotive, and communications applications.

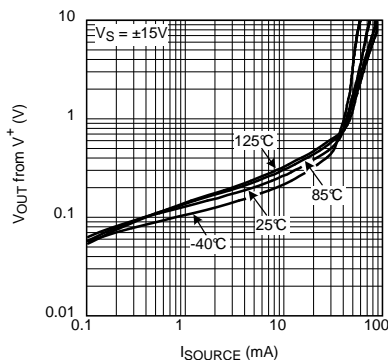
Greater than rail-to-rail input common-mode voltage range with 50 dB of common-mode rejection across this wide voltage range, allows both high-side and low-side sensing. Most device parameters are insensitive to power supply voltage, and this makes the parts easier to use where supply voltage may vary, such as automotive electrical systems and battery powered equipment. These amplifiers have true rail-to-rail output and can supply a respectable amount of current (15 mA) with minimal head-room from either rail (300 mV) at low distortion (0.05% THD+Noise).

### Device Information<sup>(1)</sup>

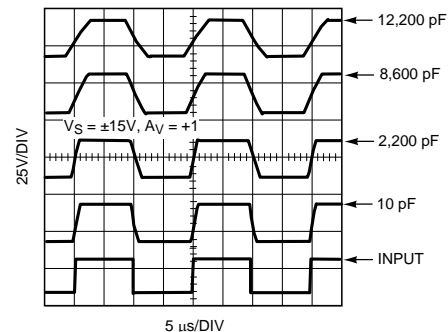
PART NUMBER	PACKAGE	BODY SIZE (NOM)
LM7321	SOIC (8)	4.90 mm x 3.91 mm
LM7322	SOT (5)	2.90 mm x 1.60 mm
LM7322	VSSOP (8)	3.00 mm x 3.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

### Output Swing vs. Sourcing Current



### Large Signal Step Response



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## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

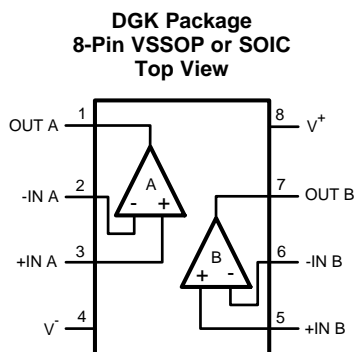
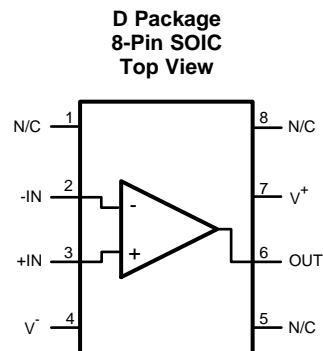
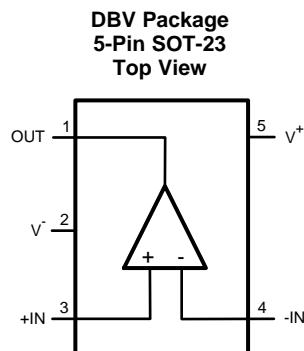
Changes from Revision D (March 2013) to Revision E	Page
<ul style="list-style-type: none"> <li>Added <i>Pin Configuration and Functions</i> section, <i>ESD Ratings</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i>, <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section .....</li> </ul>	<b>1</b>

Changes from Revision C (May 2008) to Revision D	Page
<ul style="list-style-type: none"> <li>Changed layout of National Data Sheet to TI format .....</li> </ul>	<b>25</b>

## 5 Description continued

There are several package options for each part. Standard SOIC versions of both parts make upgrading existing designs easy. LM7322x are offered in a space-saving 8-Pin VSSOP package. The LM7321x are offered in small SOT-23 package, which makes it easy to place this part close to sensors for better circuit performance.

## 6 Pin Configuration and Functions



### Pin Functions

NAME	PIN			I/O	DESCRIPTION
	SOT-23 NO.	SOIC NO.	VSSOP, SOIC NO.		
OUT	1	6	—	O	Output
OUT A	—	—	1	O	Output for Amplifier A
OUT B	—	—	7	O	Output for Amplifier B
V+	5	7	7	P	Positive Supply
V-	2	4	4	P	Negative Supply
+IN	3	3	—	I	Noninverting Input
-IN	4	2	—	I	Inverting Input
+IN A	—	—	3	I	Noninverting Input for Amplifier A
-IN A	—	—	2	I	Inverting Input for Amplifier A
+IN B	—	—	5	I	Noninverting Input for Amplifier B
-IN B	—	—	6	I	Inverting Input for Amplifier B
N/C	—	1, 5, 8	—	—	No connection

## 7 Specifications

### 7.1 Absolute Maximum Ratings

 over operating free-air temperature range (unless otherwise noted)<sup>(1)(2)</sup>

	MIN	MAX	UNIT
V <sub>IN</sub> Differential		±10	V
Output Short Circuit Current	See <sup>(3)</sup>		
Supply Voltage (V <sub>S</sub> = V <sup>+</sup> - V <sup>-</sup> )		35	V
Voltage at Input/Output pins	V <sup>+</sup> + 0.8	V <sup>-</sup> - 0.8	V
Junction Temperature <sup>(4)</sup>		150	°C
Soldering Information:	Infrared or Convection (20 sec.)	235	°C
	Wave Soldering (10 sec.)	260	°C
Storage Temperature	-65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/Distributors for availability and specifications.
- (3) Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150°C. Short circuit test is a momentary test. Output short circuit duration is infinite for V<sub>S</sub> ≤ 6V at room temperature and below. For V<sub>S</sub> > 6V, allowable short circuit duration is 1.5 ms.
- (4) The maximum power dissipation is a function of T<sub>J(MAX)</sub>, R<sub>θJA</sub>. The maximum allowable power dissipation at any ambient temperature is P<sub>D</sub> = (T<sub>J(MAX)</sub> - T<sub>A</sub>) / R<sub>θJA</sub>. All numbers apply for packages soldered directly onto a PCB.

### 7.2 ESD Ratings

	VALUE	UNIT
V <sub>(ESD)</sub> Electrostatic discharge <sup>(1)</sup>	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(2)</sup>	±2000
	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(3)</sup>	±1000
	Machine Model	200

- (1) Human Body Model, applicable std. MIL-STD-883, Method 3015.7. Machine Model, applicable std. JESD22-A115-A (ESD MM std. of JEDEC) Field-Induced Charge-Device Model, applicable std. JESD22-C101-C (ESD FICDM std. of JEDEC).
- (2) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (3) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions

	MIN	MAX	UNIT
Supply Voltage (V <sub>S</sub> = V <sup>+</sup> - V <sup>-</sup> )	2.5	32	V
Temperature Range <sup>(1)</sup>	-40	125	°C

- (1) The maximum power dissipation is a function of T<sub>J(MAX)</sub>, R<sub>θJA</sub>. The maximum allowable power dissipation at any ambient temperature is P<sub>D</sub> = (T<sub>J(MAX)</sub> - T<sub>A</sub>) / R<sub>θJA</sub>. All numbers apply for packages soldered directly onto a PCB.

### 7.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>	LM7321			UNIT
	D (SOIC)	DBV (SOT)	DGK (VSSOP)	
	8 PINS	5 PINS	8 PINS	
R <sub>θJA</sub> <sup>(2)</sup> Junction-to-ambient thermal resistance	165	325	235	°C/W

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).
- (2) The maximum power dissipation is a function of T<sub>J(MAX)</sub>, R<sub>θJA</sub>. The maximum allowable power dissipation at any ambient temperature is P<sub>D</sub> = (T<sub>J(MAX)</sub> - T<sub>A</sub>) / R<sub>θJA</sub>. All numbers apply for packages soldered directly onto a PCB.

## 7.5 2.7-V Electrical Characteristics

Unless otherwise specified, all limits ensured for  $T_A = 25^\circ\text{C}$ ,  $V^+ = 2.7\text{ V}$ ,  $V^- = 0\text{ V}$ ,  $V_{\text{CM}} = 0.5\text{ V}$ ,  $V_{\text{OUT}} = 1.35\text{ V}$ , and  $R_L > 1\text{ M}\Omega$  to  $1.35\text{ V}$ .<sup>(1)</sup>

PARAMETER		TEST CONDITION	MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT		
$V_{\text{OS}}$	Input Offset Voltage	$V_{\text{CM}} = 0.5\text{ V}$ and $V_{\text{CM}} = 2.2\text{ V}$		-5	$\pm 0.7$	+5	mV	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	-6		+6		
$\text{TC } V_{\text{OS}}$	Input Offset Voltage Temperature Drift	$V_{\text{CM}} = 0.5\text{ V}$ and $V_{\text{CM}} = 2.2\text{ V}$ <sup>(4)</sup>		$\pm 2$		$\mu\text{V}/\text{C}$		
$I_{\text{B}}$	Input Bias Current	$V_{\text{CM}} = 0.5\text{ V}$ <sup>(5)</sup>		-2	-1.2	$\mu\text{A}$		
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	-2.5				
$I_{\text{OS}}$	Input Offset Current	$V_{\text{CM}} = 0.5\text{ V}$ and $V_{\text{CM}} = 2.2\text{ V}$			0.45	1	nA	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$			20		200
CMRR	Common-Mode Rejection Ratio	$0\text{ V} \leq V_{\text{CM}} \leq 1\text{ V}$		70	100	dB		
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	60				
PSRR	Power Supply Rejection Ratio	$2.7\text{ V} \leq V_{\text{S}} \leq 30\text{ V}$		55	70	dB		
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	50				
CMVR	Common-Mode Voltage Range (Min)	CMRR > 50 dB			-0.3	-0.1	V	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$					0
CMVR	Common-Mode Voltage Range (Max)	CMRR > 50 dB		2.8	3	V		
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	2.7				
$A_{\text{VOL}}$	Open-Loop Voltage Gain	$0.5\text{ V} \leq V_{\text{O}} \leq 2.2\text{ V}$ $R_L = 10\text{ k}\Omega$ to $1.35\text{ V}$		65	72	dB		
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	62				
$A_{\text{VOL}}$	Open-Loop Voltage Gain	$0.5\text{ V} \leq V_{\text{O}} \leq 2.2\text{ V}$ $R_L = 2\text{ k}\Omega$ to $1.35\text{ V}$		59	66	dB		
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	55				
$V_{\text{OUT}}$	Output Voltage Swing High	$R_L = 10\text{ k}\Omega$ to $1.35\text{ V}$ $V_{\text{ID}} = 100\text{ mV}$			50	150	mV from either rail	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$					160
	Output Voltage Swing Low	$R_L = 2\text{ k}\Omega$ to $1.35\text{ V}$ $V_{\text{ID}} = 100\text{ mV}$			100	250		
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$					280
Output Voltage Swing Low	$R_L = 10\text{ k}\Omega$ to $1.35\text{ V}$ $V_{\text{ID}} = -100\text{ mV}$			20	120			
		$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$				150		
Output Voltage Swing Low	$R_L = 2\text{ k}\Omega$ to $1.35\text{ V}$ $V_{\text{ID}} = -100\text{ mV}$			40	120			
		$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$				150		
$I_{\text{OUT}}$	Output Current	Sourcing $V_{\text{ID}} = 200\text{ mV}$ , $V_{\text{OUT}} = 0\text{ V}$ <sup>(6)</sup>		30	48	mA		
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$					20
			Sinking $V_{\text{ID}} = -200\text{ mV}$ , $V_{\text{OUT}} = 2.7\text{ V}$ <sup>(6)</sup>		40		65	
$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$					30			

- (1) Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that  $T_J = T_A$ . No ensured specification of parametric performance is indicated in the electrical tables under conditions of internal self-heating where  $T_J > T_A$ .
- (2) All limits are ensured by testing or statistical analysis.
- (3) Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration. The typical values are not tested and are not ensured on shipped production material.
- (4) Offset voltage temperature drift determined by dividing the change in  $V_{\text{OS}}$  at temperature extremes into the total temperature change.
- (5) Positive current corresponds to current flowing into the device.
- (6) Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of  $150^\circ\text{C}$ . Short circuit test is a momentary test. Output short circuit duration is infinite for  $V_{\text{S}} \leq 6\text{ V}$  at room temperature and below. For  $V_{\text{S}} > 6\text{ V}$ , allowable short circuit duration is 1.5 ms.

## 2.7-V Electrical Characteristics (continued)

Unless otherwise specified, all limits ensured for  $T_A = 25^\circ\text{C}$ ,  $V^+ = 2.7\text{ V}$ ,  $V^- = 0\text{ V}$ ,  $V_{\text{CM}} = 0.5\text{ V}$ ,  $V_{\text{OUT}} = 1.35\text{ V}$ , and  $R_L > 1\text{ M}\Omega$  to  $1.35\text{ V}$ .<sup>(1)</sup>

PARAMETER		TEST CONDITION	MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT
$I_S$	Supply Current	LM7321	$T_A = -40^\circ\text{C to } +125^\circ\text{C}$	0.95	1.3	mA
				1.9		
		LM7322	$T_A = -40^\circ\text{C to } +125^\circ\text{C}$	2	2.5	
					3.8	
SR	Slew Rate <sup>(7)</sup>	$A_V = +1$ , $V_I = 2\text{-V Step}$		8.5		V/ $\mu\text{s}$
$f_u$	Unity Gain Frequency	$R_L = 2\text{ k}\Omega$ , $C_L = 20\text{ pF}$		7.5		MHz
GBW	Gain Bandwidth	$f = 50\text{ kHz}$		16		MHz
$e_n$	Input Referred Voltage Noise Density	$f = 2\text{ kHz}$		11.9		nV/ $\sqrt{\text{Hz}}$
$i_n$	Input Referred Current Noise Density	$f = 2\text{ kHz}$		0.5		pA/ $\sqrt{\text{Hz}}$
THD+N	Total Harmonic Distortion + Noise	$V^+ = 1.9\text{ V}$ , $V^- = -0.8\text{ V}$ $f = 1\text{ kHz}$ , $R_L = 100\text{ k}\Omega$ , $A_V = +2$ $V_{\text{OUT}} = 210\text{ mV}_{\text{PP}}$		-77		dB
CT Rej.	Crosstalk Rejection	$f = 100\text{ kHz}$ , Driver $R_L = 10\text{ k}\Omega$		60		dB

(7) Slew rate is the slower of the rising and falling slew rates. Connected as a Voltage Follower.

## 7.6 ±5-V Electrical Characteristics

Unless otherwise specified, all limited ensured for  $T_A = 25^\circ\text{C}$ ,  $V^+ = 5\text{ V}$ ,  $V^- = -5\text{ V}$ ,  $V_{\text{CM}} = 0\text{ V}$ ,  $V_{\text{OUT}} = 0\text{ V}$ , and  $R_L > 1\text{ M}\Omega$  to 0 V.<sup>(1)</sup>

PARAMETER		TEST CONDITION	MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT	
$V_{\text{OS}}$	Input Offset Voltage	$V_{\text{CM}} = -4.5\text{ V}$ and $V_{\text{CM}} = 4.5\text{ V}$		-5	±0.7	+5	mV
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	-6		+6	
TC $V_{\text{OS}}$	Input Offset Voltage Temperature Drift	$V_{\text{CM}} = -4.5\text{ V}$ and $V_{\text{CM}} = 4.5\text{ V}$ <sup>(4)</sup>		±2		µV/°C	
$I_{\text{B}}$	Input Bias Current	$V_{\text{CM}} = -4.5\text{ V}$ <sup>(5)</sup>		-2.0	-1.2	µA	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	-2.5			
$I_{\text{OS}}$	Input Offset Current	$V_{\text{CM}} = -4.5\text{ V}$ and $V_{\text{CM}} = 4.5\text{ V}$		0.45	1	nA	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		20		200
CMRR	Common Mode Rejection Ratio	$-5\text{ V} \leq V_{\text{CM}} \leq 3\text{ V}$		78	100	dB	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	70			
			$-5\text{ V} \leq V_{\text{CM}} \leq 5\text{ V}$	65	80		
PSRR	Power Supply Rejection Ratio	$2.7\text{ V} \leq V_{\text{S}} \leq 30\text{ V}$ , $V_{\text{CM}} = -4.5\text{ V}$		78	104	dB	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	74			
CMVR	Common-Mode Voltage Range (Min)	CMRR > 50 dB		-5.3	-5.1	V	
	$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$			-5			
	Common-Mode Voltage Range (Max)	CMRR > 50 dB		5.1	5.3		
	$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		5				
$A_{\text{VOL}}$	Open-Loop Voltage Gain	$-4\text{ V} \leq V_{\text{O}} \leq 4\text{ V}$ $R_L = 10\text{ k}\Omega$ to 0 V		74	80	dB	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	70			
			$-4\text{ V} \leq V_{\text{O}} \leq 4\text{ V}$ $R_L = 2\text{ k}\Omega$ to 0 V	68	74		
$V_{\text{OUT}}$	Output Voltage Swing High	$R_L = 10\text{ k}\Omega$ to 0 V $V_{\text{ID}} = 100\text{ mV}$		100	250	mV from either rail	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		280		
			$R_L = 2\text{ k}\Omega$ to 0 V $V_{\text{ID}} = 100\text{ mV}$		160		350
	$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		450				
	Output Voltage Swing Low	$R_L = 10\text{ k}\Omega$ to 0 V $V_{\text{ID}} = -100\text{ mV}$		35	200		
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		250		
$R_L = 2\text{ k}\Omega$ to 0 V $V_{\text{ID}} = -100\text{ mV}$				80	200		
$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		250					
$I_{\text{OUT}}$	Output Current	Sourcing $V_{\text{ID}} = 200\text{ mV}$ , $V_{\text{OUT}} = -5\text{ V}$ <sup>(6)</sup>		35	70	mA	
			$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	20			
			Sinking $V_{\text{ID}} = -200\text{ mV}$ , $V_{\text{OUT}} = 5\text{ V}$ <sup>(6)</sup>		50		85
$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	30						

- (1) Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that  $T_J = T_A$ . No ensured specification of parametric performance is indicated in the electrical tables under conditions of internal self-heating where  $T_J > T_A$ .
- (2) All limits are ensured by testing or statistical analysis.
- (3) Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration. The typical values are not tested and are not ensured on shipped production material.
- (4) Offset voltage temperature drift determined by dividing the change in  $V_{\text{OS}}$  at temperature extremes into the total temperature change.
- (5) Positive current corresponds to current flowing into the device.
- (6) Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of  $150^\circ\text{C}$ . Short circuit test is a momentary test. Output short circuit duration is infinite for  $V_{\text{S}} \leq 6\text{ V}$  at room temperature and below. For  $V_{\text{S}} > 6\text{ V}$ , allowable short circuit duration is 1.5 ms.

## ±5-V Electrical Characteristics (continued)

Unless otherwise specified, all limited ensured for  $T_A = 25^\circ\text{C}$ ,  $V^+ = 5\text{ V}$ ,  $V^- = -5\text{ V}$ ,  $V_{CM} = 0\text{ V}$ ,  $V_{OUT} = 0\text{ V}$ , and  $R_L > 1\text{ M}\Omega$  to 0 V.<sup>(1)</sup>

PARAMETER		TEST CONDITION		MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT
$I_S$	Supply Current	$V_{CM} = -4.5\text{ V}$	LM7321	$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	1.0	1.3	mA
					2		
			LM7322	$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	2.3	2.8	
					3.8		
SR	Slew Rate <sup>(7)</sup>	$A_V = +1$ , $V_I = 8\text{-V}$ Step		12.3		V/ $\mu\text{s}$	
$f_u$	Unity Gain Frequency	$R_L = 2\text{ k}\Omega$ , $C_L = 20\text{ pF}$		9		MHz	
GBW	Gain Bandwidth	$f = 50\text{ kHz}$		16		MHz	
$e_n$	Input Referred Voltage Noise Density	$f = 2\text{ kHz}$		14.3		nV/ $\sqrt{\text{Hz}}$	
$i_n$	Input Referred Current Noise Density	$f = 2\text{ kHz}$		1.35		pA/ $\sqrt{\text{Hz}}$	
THD+N	Total Harmonic Distortion + Noise	$f = 1\text{ kHz}$ , $R_L = 100\text{ k}\Omega$ , $A_V = +2$ $V_{OUT} = 8\text{ V}_{PP}$		-79		dB	
CT Rej.	Crosstalk Rejection	$f = 100\text{ kHz}$ , Driver $R_L = 10\text{ k}\Omega$		60		dB	

(7) Slew rate is the slower of the rising and falling slew rates. Connected as a Voltage Follower.

## 7.7 ±15-V Electrical Characteristics

Unless otherwise specified, all limited ensured for  $T_A = 25^\circ\text{C}$ ,  $V^+ = 15\text{ V}$ ,  $V^- = -15\text{ V}$ ,  $V_{CM} = 0\text{ V}$ ,  $V_{OUT} = 0\text{ V}$ , and  $R_L > 1\text{ M}\Omega$  to 15 V.<sup>(1)</sup>

PARAMETER		TEST CONDITION		MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT
$V_{OS}$	Input Offset Voltage	$V_{CM} = -14.5\text{ V}$ and $V_{CM} = 14.5\text{ V}$		-6	$\pm 0.7$	+6	mV
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$	-8		+8	
TC $V_{OS}$	Input Offset Voltage Temperature Drift	$V_{CM} = -14.5\text{ V}$ and $V_{CM} = 14.5\text{ V}$ <sup>(4)</sup>			$\pm 2$		$\mu\text{V}/^\circ\text{C}$
$I_B$	Input Bias Current	$V_{CM} = -14.5\text{ V}$ <sup>(5)</sup>		-2	-1.1		$\mu\text{A}$
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$	-2.5			
			$V_{CM} = 14.5\text{ V}$ <sup>(5)</sup>		0.45	1	
$I_{OS}$	Input Offset Current	$V_{CM} = -14.5\text{ V}$ and $V_{CM} = 14.5\text{ V}$			30	300	nA
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$			500	
CMRR	Common-Mode Rejection Ratio	$-15\text{ V} \leq V_{CM} \leq 12\text{ V}$		80	100		dB
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$	75			
		$-15\text{ V} \leq V_{CM} \leq 15\text{ V}$		72	80		
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$	70			
PSRR	Power Supply Rejection Ratio	$2.7\text{ V} \leq V_S \leq 30\text{ V}$ , $V_{CM} = -14.5\text{ V}$		78	100		dB
			$-40^\circ\text{C}$ to $+125^\circ\text{C}$	74			

(1) Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that  $T_J = T_A$ . No ensured specification of parametric performance is indicated in the electrical tables under conditions of internal self-heating where  $T_J > T_A$ .

(2) All limits are ensured by testing or statistical analysis.

(3) Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration. The typical values are not tested and are not ensured on shipped production material.

(4) Offset voltage temperature drift determined by dividing the change in  $V_{OS}$  at temperature extremes into the total temperature change.

(5) Positive current corresponds to current flowing into the device.

**±15-V Electrical Characteristics (continued)**

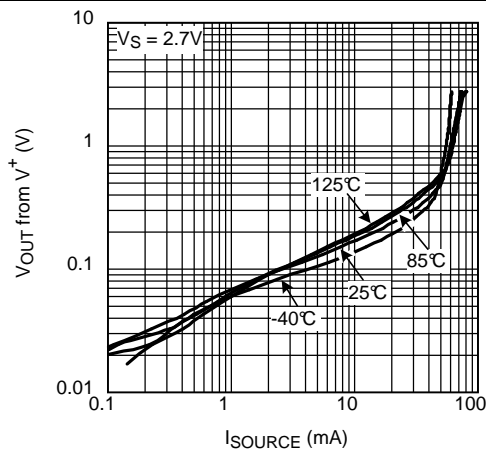
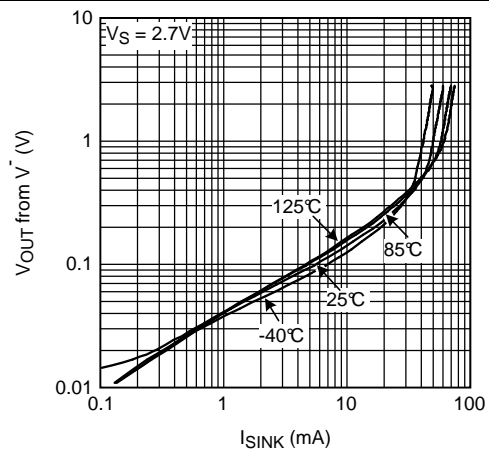
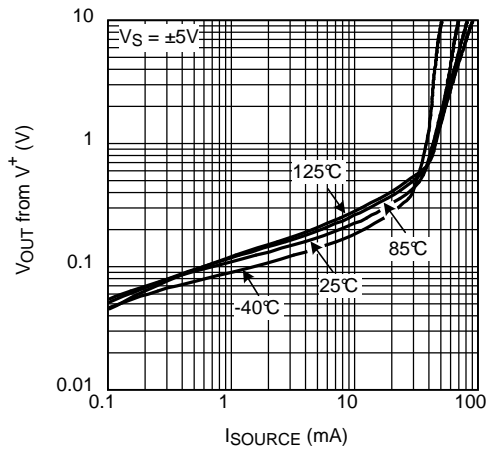
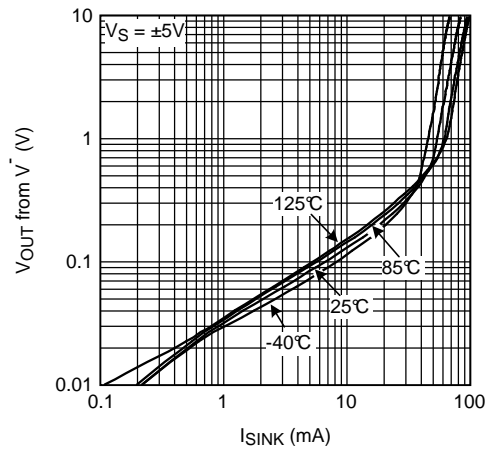
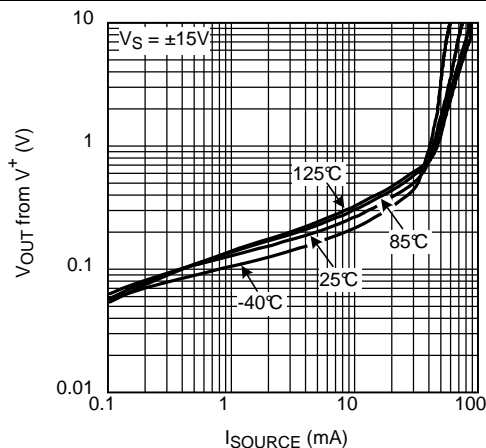
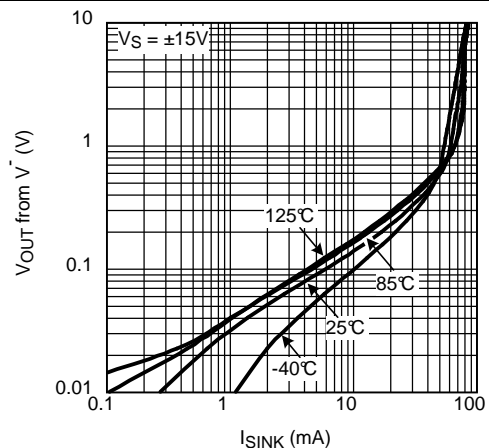
Unless otherwise specified, all limited ensured for  $T_A = 25^\circ\text{C}$ ,  $V^+ = 15\text{ V}$ ,  $V^- = -15\text{ V}$ ,  $V_{\text{CM}} = 0\text{ V}$ ,  $V_{\text{OUT}} = 0\text{ V}$ , and  $R_L > 1\text{ M}\Omega$  to  $15\text{ V}$ .<sup>(1)</sup>

PARAMETER		TEST CONDITION		MIN <sup>(2)</sup>	TYP <sup>(3)</sup>	MAX <sup>(2)</sup>	UNIT
CMVR	Common-Mode Voltage Range (Min)	CMRR > 50 dB	–40°C to +125°C		–15.3	–15.1	V
	Common-Mode Voltage Range (Max)				15.1	15.3	
A <sub>VOL</sub>	Open-Loop Voltage Gain	–13 V ≤ V <sub>O</sub> ≤ 13 V R <sub>L</sub> = 10 kΩ to 0 V	–40°C to +125°C	75	85	dB	
			–40°C to +125°C	70			
		–13 V ≤ V <sub>O</sub> ≤ 13 V R <sub>L</sub> = 2 kΩ to 0 V	–40°C to +125°C	70	78		
V <sub>OUT</sub>	Output Voltage Swing High	R <sub>L</sub> = 10 kΩ to 0 V V <sub>ID</sub> = 100 mV	–40°C to +125°C		150	300	mV from either rail
			–40°C to +125°C			350	
		R <sub>L</sub> = 2 kΩ to 0 V V <sub>ID</sub> = 100 mV	–40°C to +125°C		250	550	
	Output Voltage Swing Low	R <sub>L</sub> = 10 kΩ to 0 V V <sub>ID</sub> = –100 mV	–40°C to +125°C		60	200	
			–40°C to +125°C			250	
		R <sub>L</sub> = 2 kΩ to 0 V V <sub>ID</sub> = –100 mV	–40°C to +125°C		130	300	
I <sub>OUT</sub>	Output Current	Sourcing V <sub>ID</sub> = 200 mV, V <sub>OUT</sub> = –15 V <sup>(6)</sup>		40	65	mA	
		Sinking V <sub>ID</sub> = –200 mV, V <sub>OUT</sub> = 15 V <sup>(6)</sup>		60	100		
I <sub>S</sub>	Supply Current	V <sub>CM</sub> = –14.5 V	LM7321	–40°C to +125°C	1.1	1.7	mA
				–40°C to +125°C		2.4	
			LM7322	–40°C to +125°C	2.5	4	
				–40°C to +125°C		5.6	
SR	Slew Rate <sup>(7)</sup>	A <sub>V</sub> = +1, V <sub>I</sub> = 20-V Step			18	V/μs	
f <sub>u</sub>	Unity Gain Frequency	R <sub>L</sub> = 2 kΩ, C <sub>L</sub> = 20 pF			11.3	MHz	
GBW	Gain Bandwidth	f = 50 kHz			20	MHz	
e <sub>n</sub>	Input Referred Voltage Noise Density	f = 2 kHz			15	nV/√Hz	
i <sub>n</sub>	Input Referred Current Noise Density	f = 2 kHz			1.3	pA/√Hz	
THD+N	Total Harmonic Distortion +Noise	f = 1 kHz, R <sub>L</sub> 100 kΩ, A <sub>V</sub> = +2, V <sub>OUT</sub> = 23 V <sub>PP</sub>			–86	dB	
CT Rej.	Crosstalk Rejection	f = 100 kHz, Driver R <sub>L</sub> = 10 kΩ			60	dB	

(6) Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150°C. Short circuit test is a momentary test. Output short circuit duration is infinite for  $V_S \leq 6\text{ V}$  at room temperature and below. For  $V_S > 6\text{ V}$ , allowable short circuit duration is 1.5 ms.

(7) Slew rate is the slower of the rising and falling slew rates. Connected as a Voltage Follower.

## 7.8 Typical Characteristics

 Unless otherwise specified:  $T_A = 25^\circ\text{C}$ .

**Figure 1. Output Swing vs. Sourcing Current**

**Figure 2. Output Swing vs. Sinking Current**

**Figure 3. Output Swing vs. Sourcing Current**

**Figure 4. Output Swing vs. Sinking Current**

**Figure 5. Output Swing vs. Sourcing Current**

**Figure 6. Output Swing vs. Sinking Current**

Typical Characteristics (continued)

Unless otherwise specified:  $T_A = 25^\circ\text{C}$ .

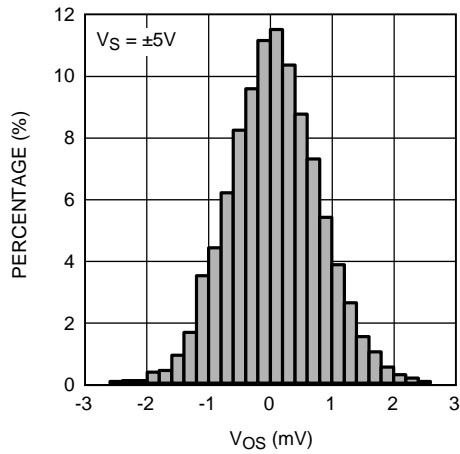


Figure 7.  $V_{OS}$  Distribution

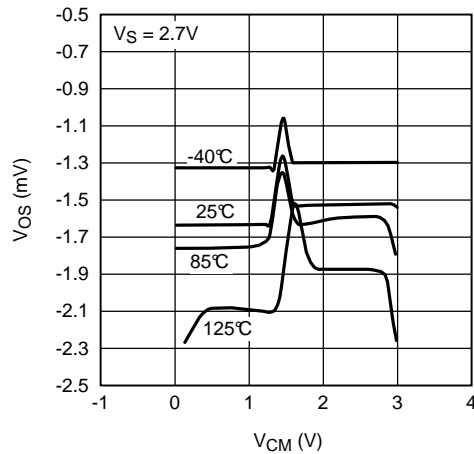


Figure 8.  $V_{OS}$  vs.  $V_{CM}$  (Unit 1)

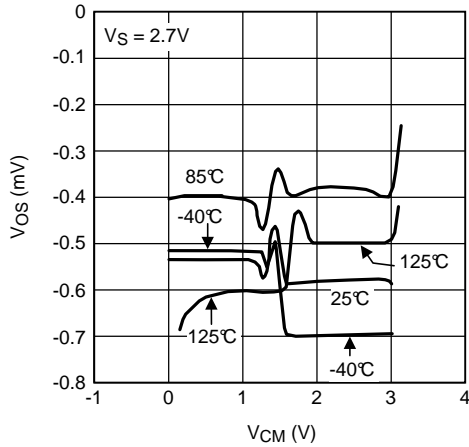


Figure 9.  $V_{OS}$  vs.  $V_{CM}$  (Unit 2)

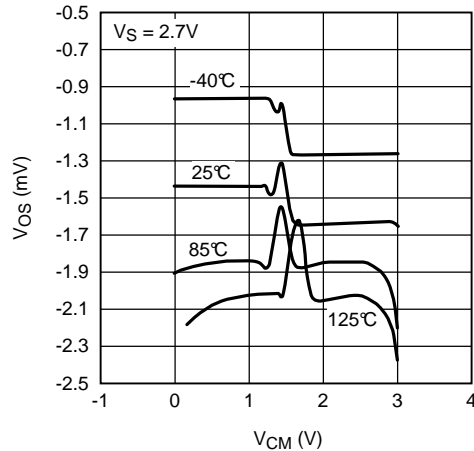


Figure 10.  $V_{OS}$  vs.  $V_{CM}$  (Unit 3)

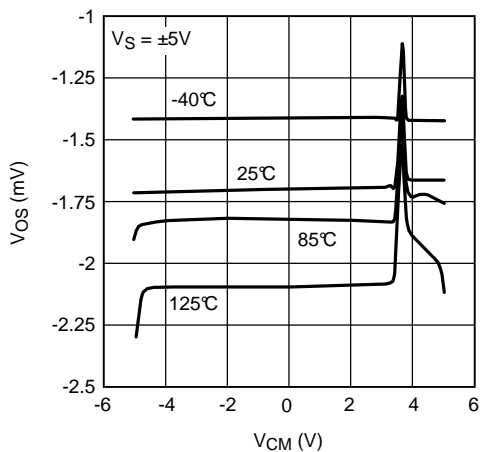


Figure 11.  $V_{OS}$  vs.  $V_{CM}$  (Unit 1)

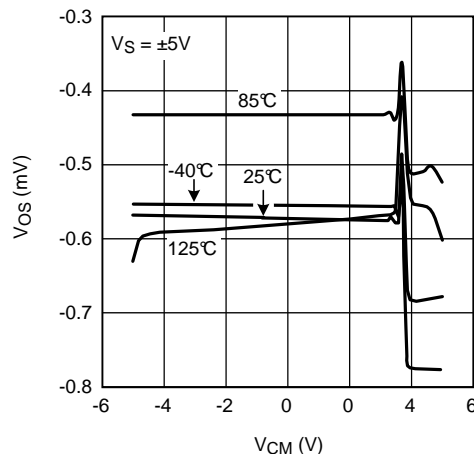


Figure 12.  $V_{OS}$  vs.  $V_{CM}$  (Unit 2)

Typical Characteristics (continued)

Unless otherwise specified:  $T_A = 25^\circ\text{C}$ .

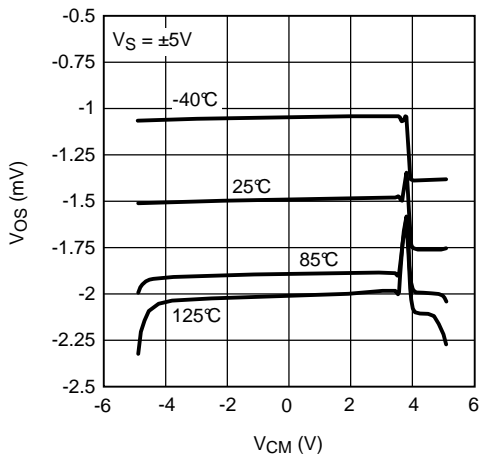


Figure 13.  $V_{OS}$  vs.  $V_{CM}$  (Unit 2)

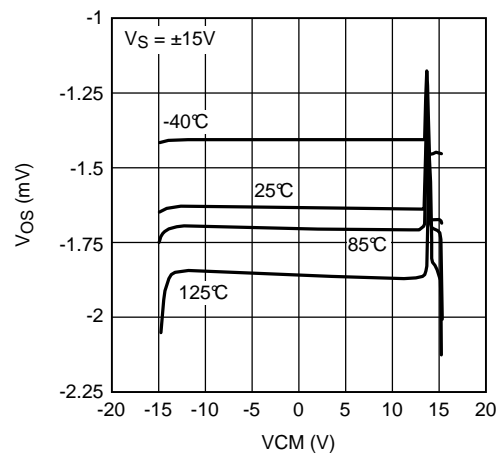


Figure 14.  $V_{OS}$  vs.  $V_{CM}$  (Unit 1)

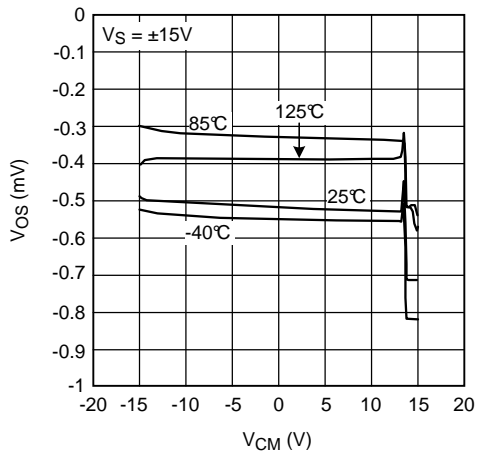


Figure 15.  $V_{OS}$  vs.  $V_{CM}$  (Unit 2)

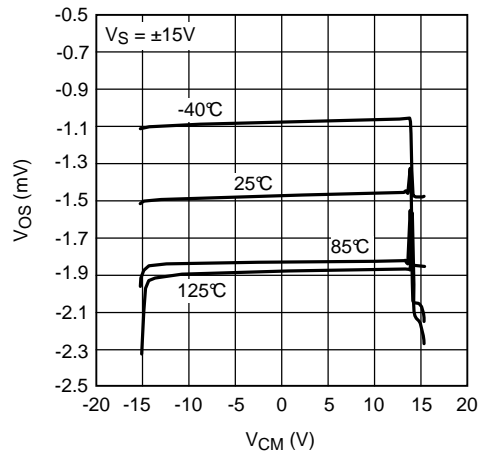


Figure 16.  $V_{OS}$  vs.  $V_{CM}$  (Unit 3)

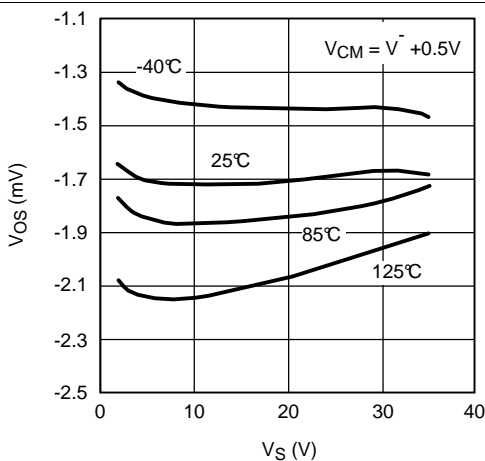


Figure 17.  $V_{OS}$  vs.  $V_S$  (Unit 1)

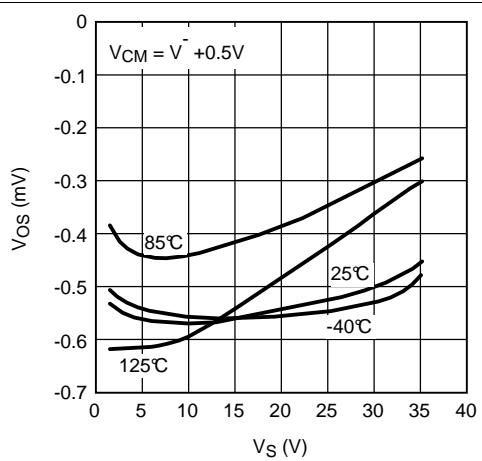


Figure 18.  $V_{OS}$  vs.  $V_S$  (Unit 2)

Typical Characteristics (continued)

Unless otherwise specified:  $T_A = 25^\circ\text{C}$ .

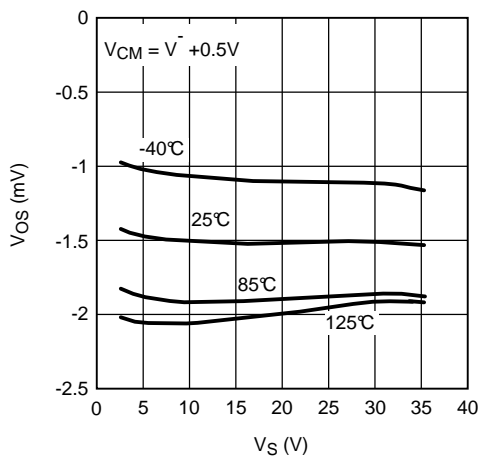


Figure 19.  $V_{OS}$  vs.  $V_S$  (Unit 3)

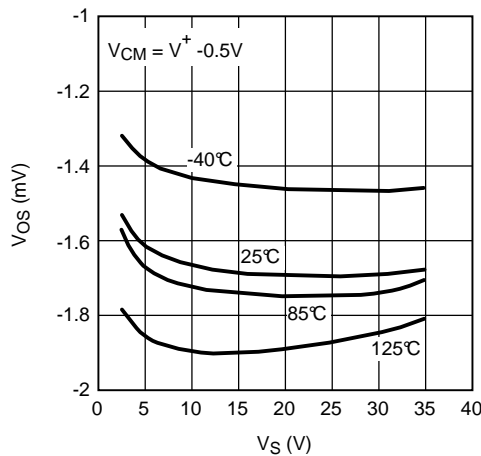


Figure 20.  $V_{OS}$  vs.  $V_S$  (Unit 1)

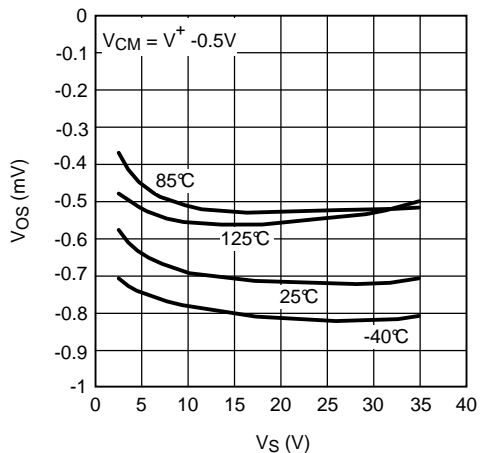


Figure 21.  $V_{OS}$  vs.  $V_S$  (Unit 2)

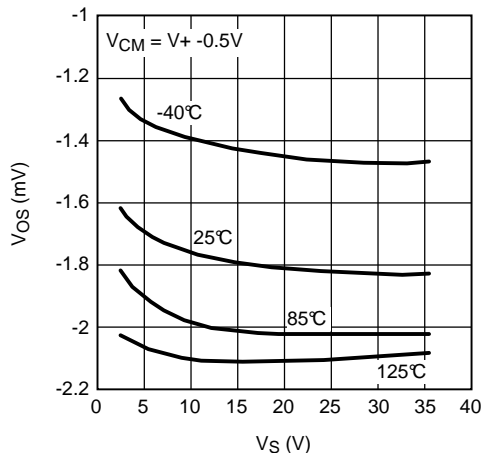


Figure 22.  $V_{OS}$  vs.  $V_S$  (Unit 3)

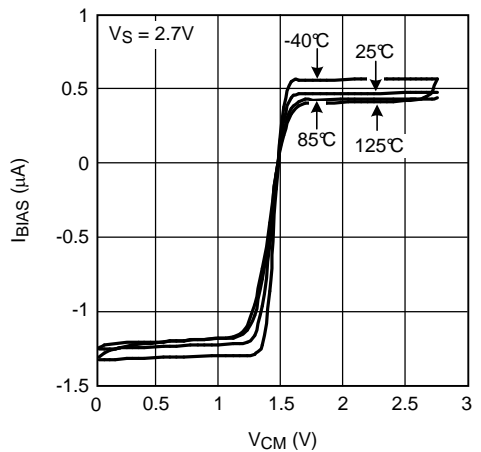


Figure 23.  $I_{BIAS}$  vs.  $V_{CM}$

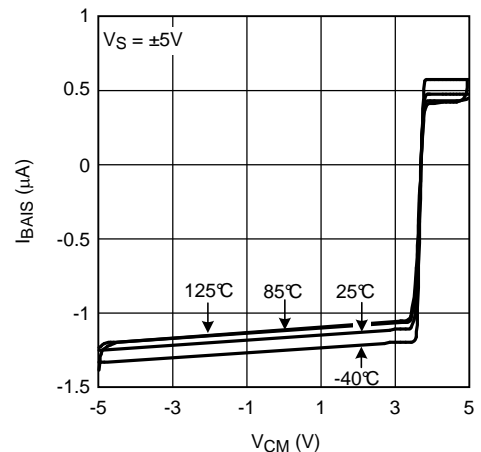


Figure 24.  $I_{BIAS}$  vs.  $V_{CM}$

Typical Characteristics (continued)

Unless otherwise specified:  $T_A = 25^\circ\text{C}$ .

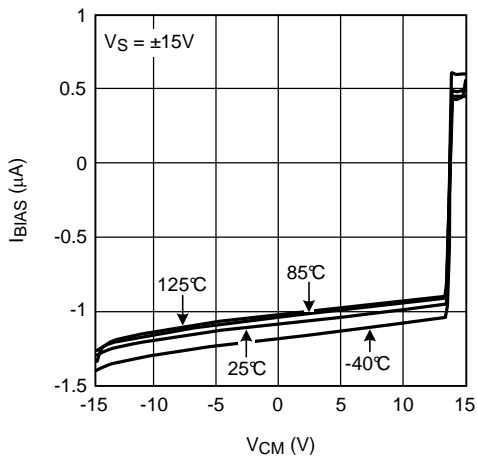


Figure 25.  $I_{BIAS}$  vs.  $V_{CM}$

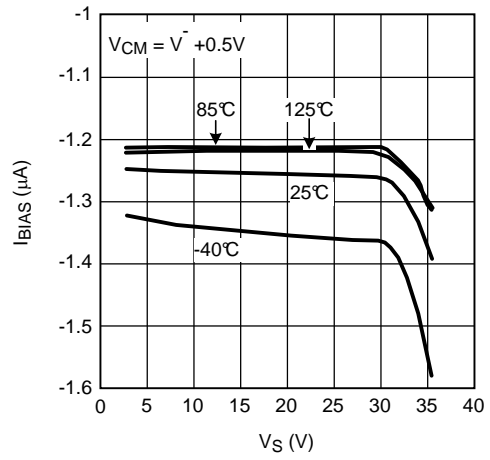


Figure 26.  $I_{BIAS}$  vs.  $V_S$

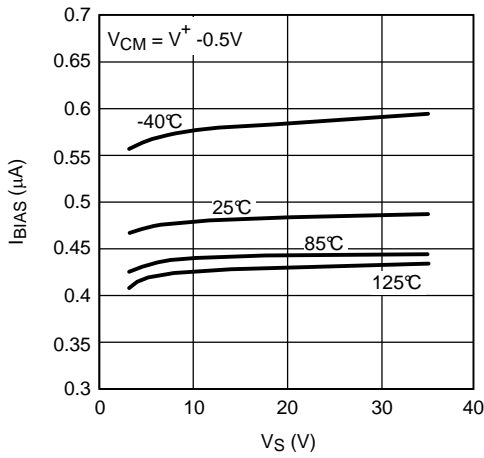


Figure 27.  $I_{BIAS}$  vs.  $V_S$

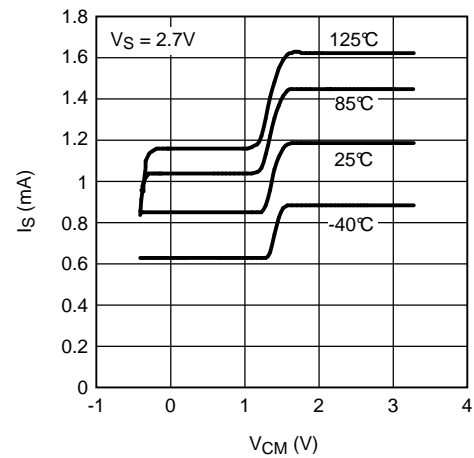


Figure 28.  $I_S$  vs.  $V_{CM}$  (LM7321)

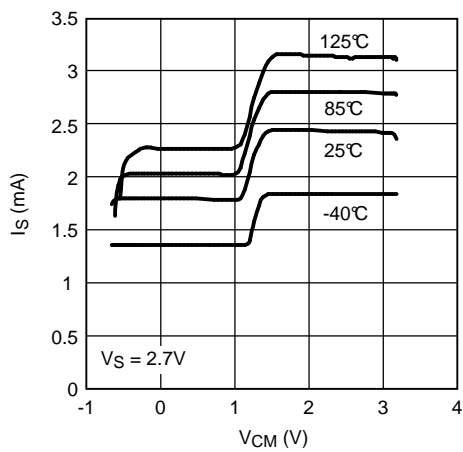


Figure 29.  $I_S$  vs.  $V_{CM}$  (LM7322)

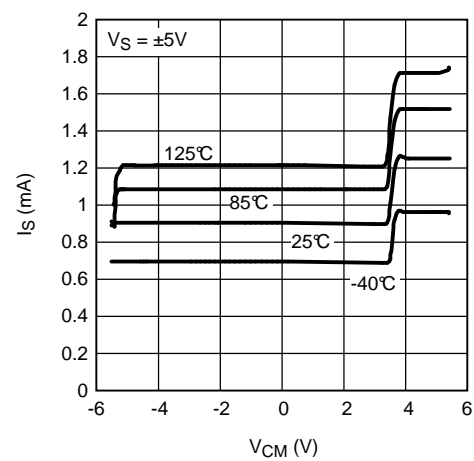


Figure 30.  $I_S$  vs.  $V_{CM}$  (LM7321)

Typical Characteristics (continued)

Unless otherwise specified:  $T_A = 25^\circ\text{C}$ .

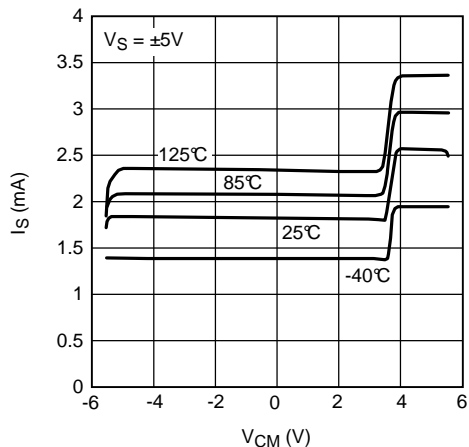


Figure 31.  $I_S$  vs.  $V_{CM}$  (LM7322)

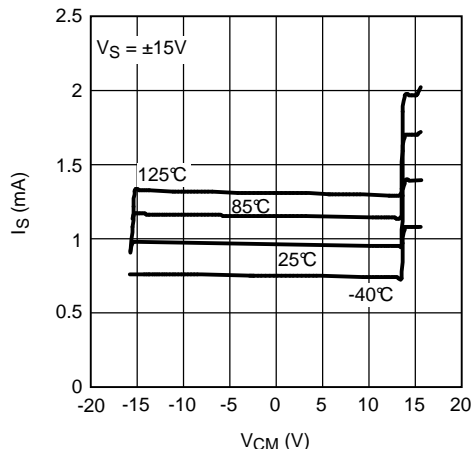


Figure 32.  $I_S$  vs.  $V_{CM}$  (LM7321)

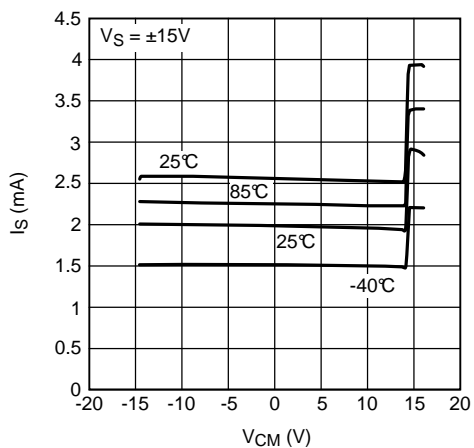


Figure 33.  $I_S$  vs.  $V_{CM}$  (LM7322)

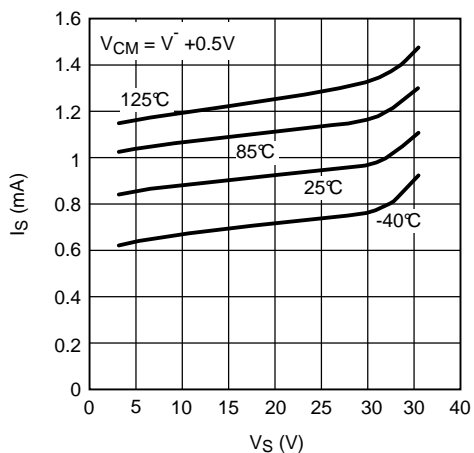


Figure 34.  $I_S$  vs.  $V_S$  (LM7321)

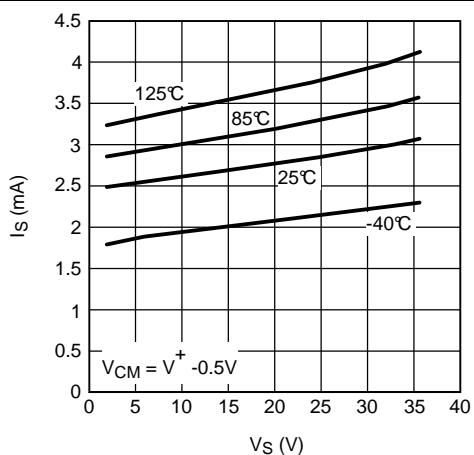


Figure 35.  $I_S$  vs.  $V_S$  (LM7322)

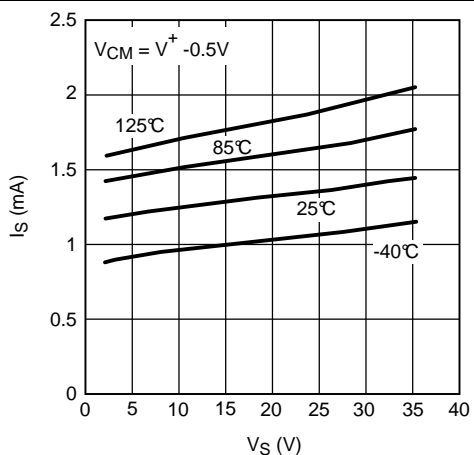


Figure 36.  $I_S$  vs.  $V_S$  (LM7321)

Typical Characteristics (continued)

Unless otherwise specified:  $T_A = 25^\circ\text{C}$ .

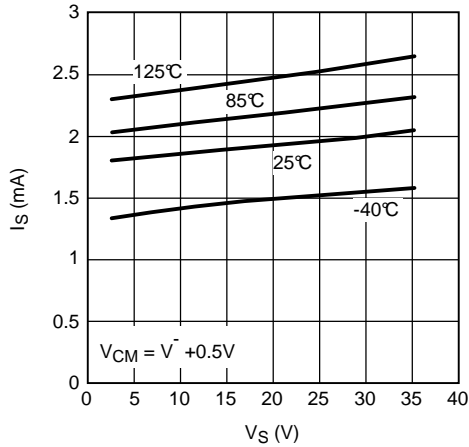


Figure 37.  $I_S$  vs.  $V_S$  (LM7322)

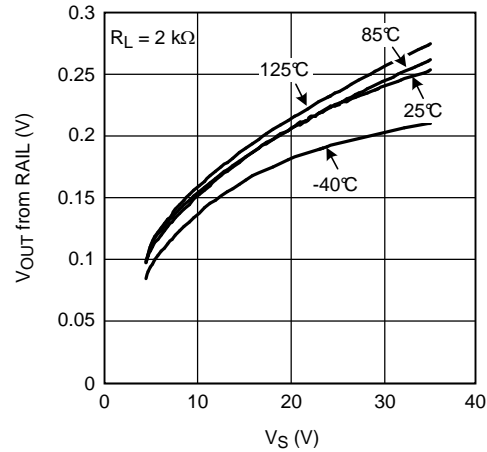


Figure 38. Positive Output Swing vs. Supply Voltage

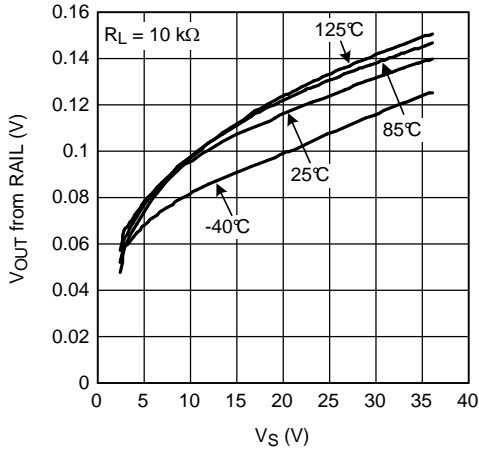


Figure 39. Positive Output Swing vs. Supply Voltage

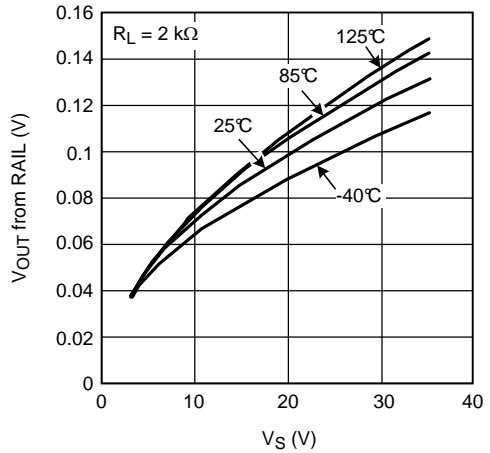


Figure 40. Negative Output Swing vs. Supply Voltage

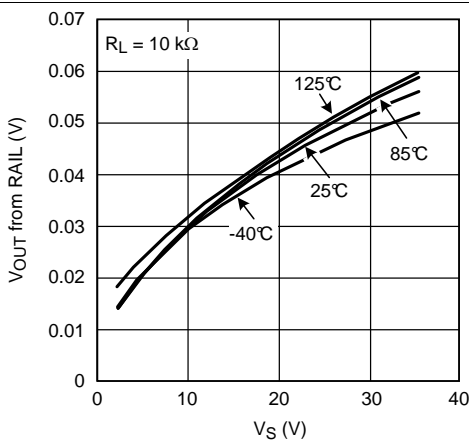


Figure 41. Negative Output Swing vs. Supply Voltage

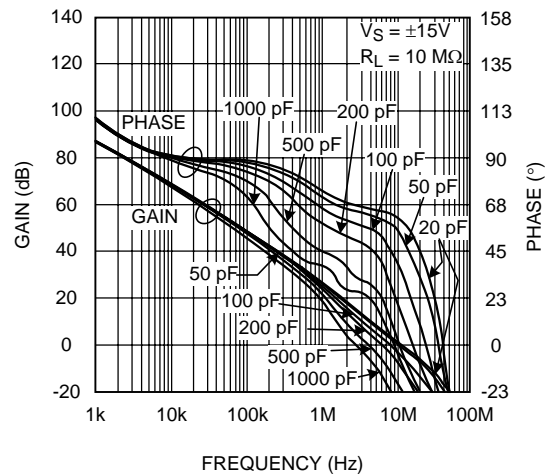


Figure 42. Open-Loop Frequency Response with Various Capacitive Load

Typical Characteristics (continued)

Unless otherwise specified:  $T_A = 25^\circ\text{C}$ .

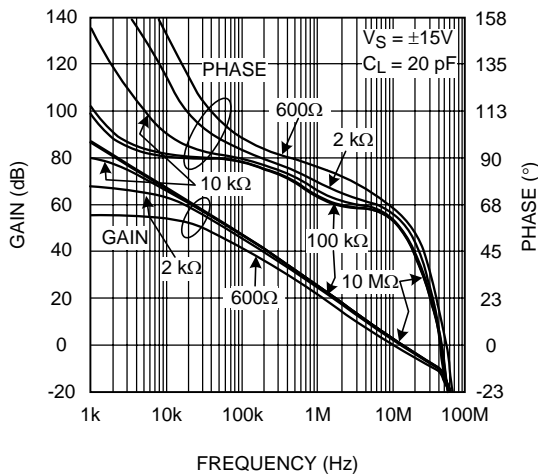


Figure 43. Open-Loop Frequency Response with Various Resistive Load

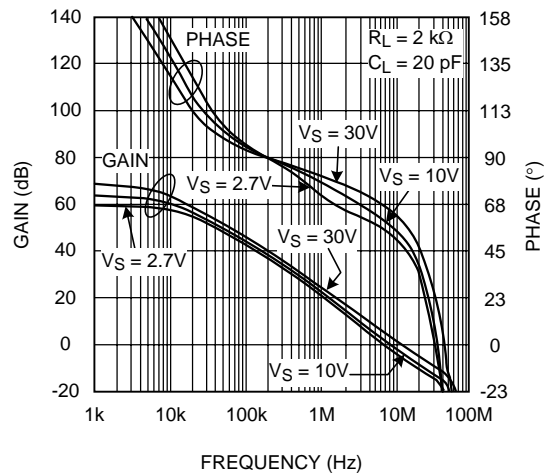


Figure 44. Open-Loop Frequency Response with Various Supply Voltage

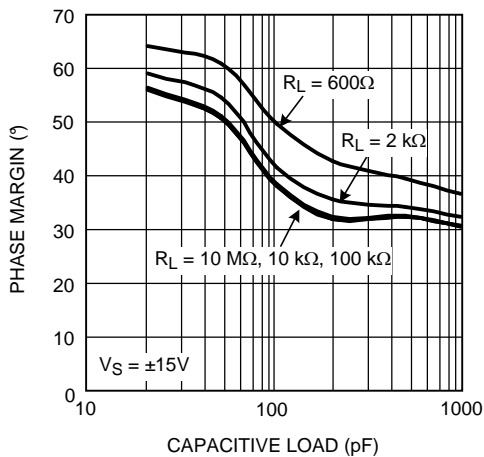


Figure 45. Phase Margin vs. Capacitive Load

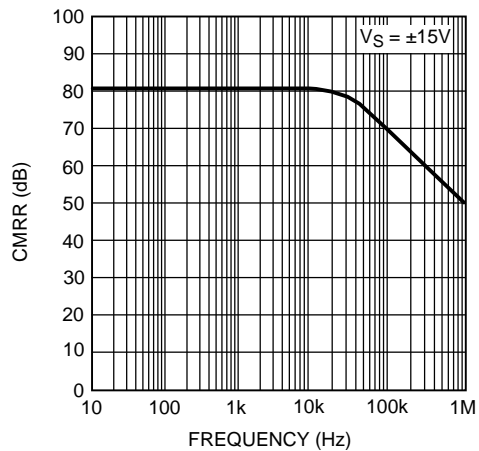


Figure 46. CMRR vs. Frequency

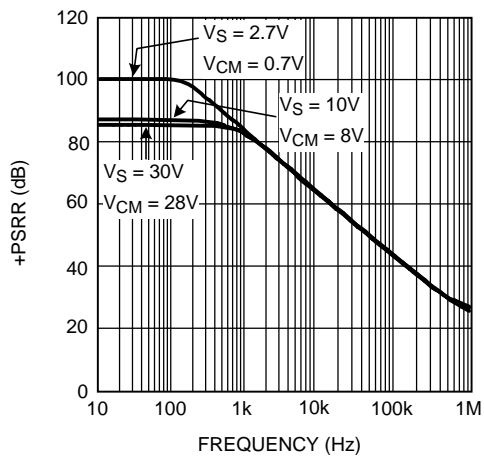


Figure 47. +PSRR vs. Frequency

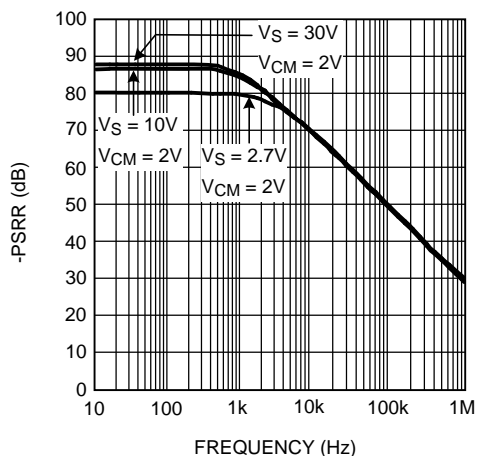


Figure 48. -PSRR vs. Frequency

Typical Characteristics (continued)

Unless otherwise specified:  $T_A = 25^\circ\text{C}$ .

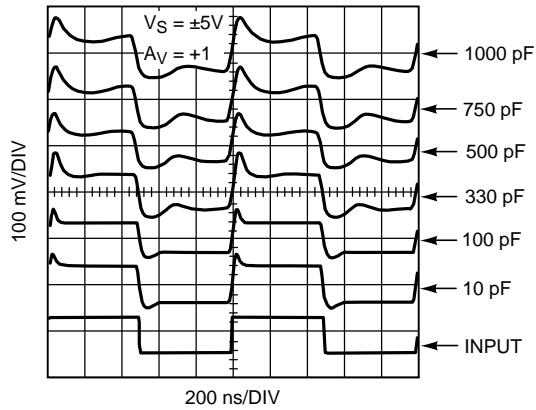


Figure 49. Small Signal Step Response

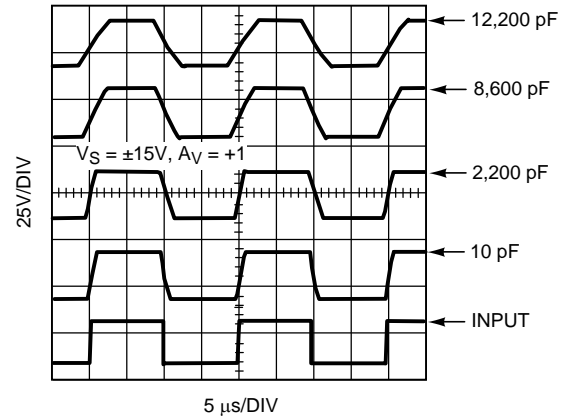


Figure 50. Large Signal Step Response

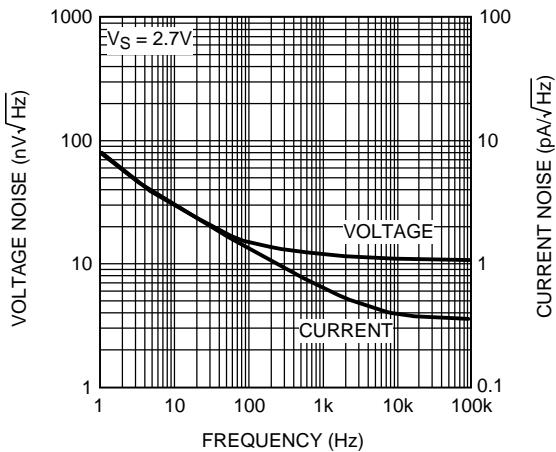


Figure 51. Input Referred Noise Density vs. Frequency

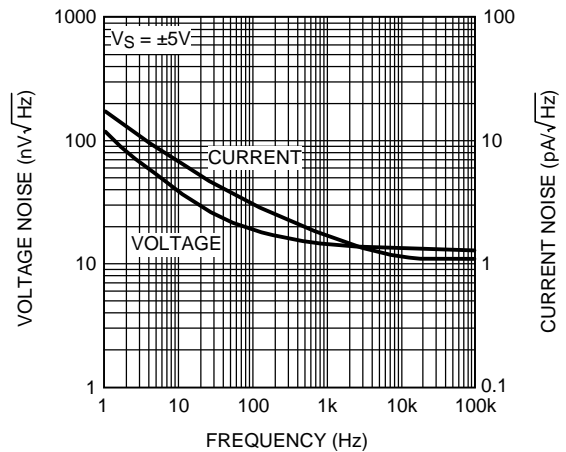


Figure 52. Input Referred Noise Density vs. Frequency

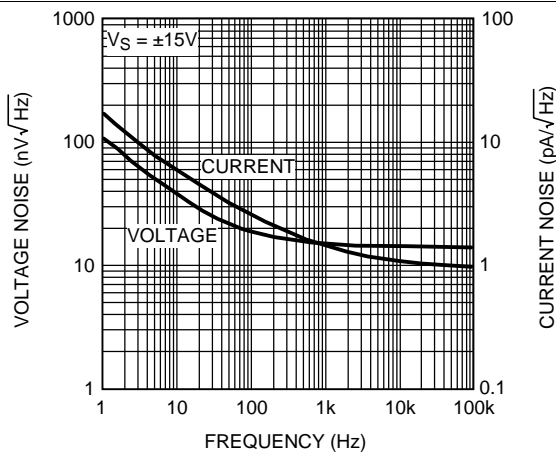


Figure 53. Input Referred Noise Density vs. Frequency

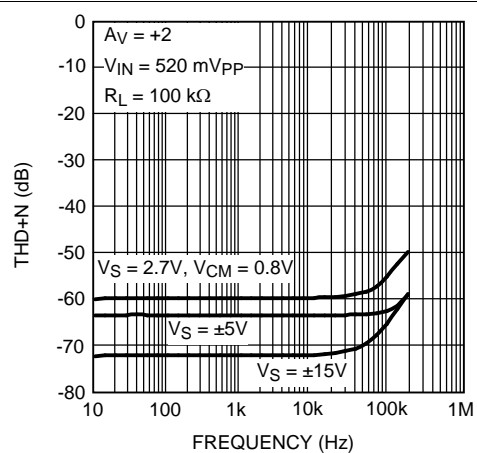


Figure 54. THD+N vs. Frequency

## Typical Characteristics (continued)

Unless otherwise specified:  $T_A = 25^\circ\text{C}$ .

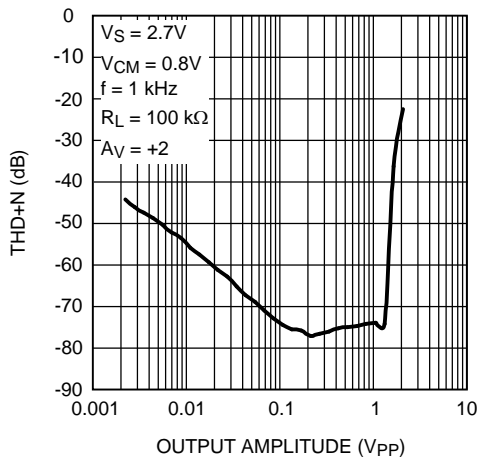


Figure 55. THD+N vs. Output Amplitude

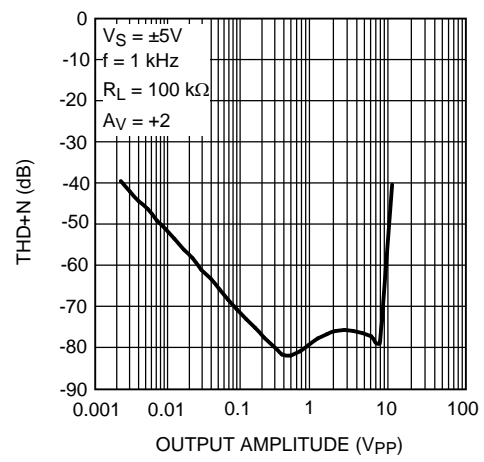


Figure 56. THD+N vs. Output Amplitude

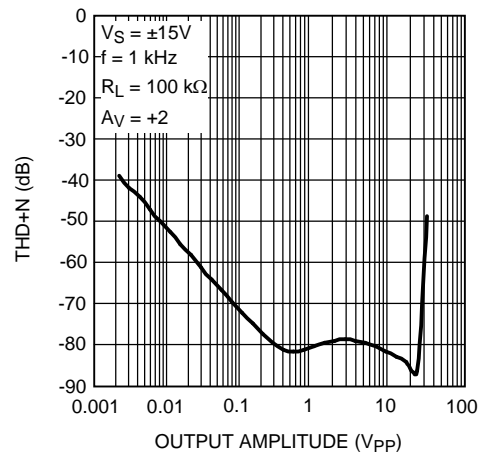


Figure 57. THD+N vs. Output Amplitude

## 8 Detailed Description

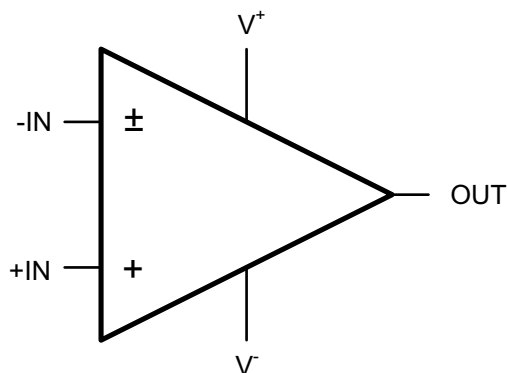
### 8.1 Overview

The LM732xx devices are rail-to-rail input and output amplifiers with wide operating voltages and high-output currents. The LM732xx family is efficient, achieving 18-V/ $\mu$ s slew rate and 20-MHz unity gain bandwidth while requiring only 1 mA of supply current per op amp. The LM732xx device performance is fully specified for operation at 2.7 V,  $\pm 5$  V and  $\pm 15$  V.

The LM732xx devices are designed to drive unlimited capacitive loads without oscillations. All LM7321x and LM7322x parts are tested at  $-40^{\circ}\text{C}$ ,  $125^{\circ}\text{C}$ , and  $25^{\circ}\text{C}$ , with modern automatic test equipment. High performance from  $-40^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ , detailed specifications, and extensive testing makes them suitable for industrial, automotive, and communications applications.

Greater than rail-to-rail input common-mode voltage range with 50 dB of common-mode rejection across this wide voltage range, allows both high-side and low-side sensing. Most device parameters are insensitive to power supply voltage, and this makes the parts easier to use where supply voltage may vary, such as automotive electrical systems and battery-powered equipment. These amplifiers have true rail-to-rail output and can supply a respectable amount of current (15 mA) with minimal head room from either rail (300 mV) at low distortion (0.05% THD+Noise).

### 8.2 Functional Block Diagram



### 8.3 Feature Description

#### 8.3.1 Output Short Circuit Current and Dissipation Issues

The LM732xx output stage is designed for maximum output current capability. Even though momentary output shorts to ground and either supply can be tolerated at all operating voltages, longer lasting short conditions can cause the junction temperature to rise beyond the absolute maximum rating of the device, especially at higher supply voltage conditions. Below supply voltage of 6 V, the output short circuit condition can be tolerated indefinitely.

With the op amp tied to a load, the device power dissipation consists of the quiescent power due to the supply current flow into the device, in addition to power dissipation due to the load current. The load portion of the power itself could include an average value (due to a DC load current) and an AC component. DC load current would flow if there is an output voltage offset, or the output AC average current is non-zero, or if the op amp operates in a single supply application where the output is maintained somewhere in the range of linear operation.

Therefore,

$$P_{\text{TOTAL}} = P_{\text{Q}} + P_{\text{DC}} + P_{\text{AC}} \quad (1)$$

## Feature Description (continued)

The Op Amp Quiescent Power Dissipation is calculated as:

$$P_Q = I_S \times V_S$$

where

- $I_S$ : Supply Current
  - $V_S$ : Total Supply Voltage ( $V^+ - V^-$ )
- (2)

The DC Load Power is calculated as:

$$P_{DC} = I_O \times (V_r - V_o)$$

where

- $V_o$ : Average Output Voltage
  - $V_r$ :  $V^+$  for sourcing and  $V^-$  for sinking current
- (3)

The AC Load Power is calculated as  $P_{AC}$  = See [Table 1](#).

[Table 1](#) shows the maximum AC component of the load power dissipated by the op amp for standard Sinusoidal, Triangular, and Square Waveforms:

**Table 1. Normalized AC Power Dissipated in the Output Stage for Standard Waveforms**

	$P_{AC} (W.\Omega/V^2)$		
	Sinusoidal	Triangular	Square
	$50.7 \times 10^{-3}$	$46.9 \times 10^{-3}$	$62.5 \times 10^{-3}$

The table entries are normalized to  $V_S^2/R_L$ . To figure out the AC load current component of power dissipation, simply multiply the table entry corresponding to the output waveform by the factor  $V_S^2/R_L$ . For example, with  $\pm 12$ -V supplies, a 600- $\Omega$  load, and triangular waveform power dissipation in the output stage is calculated as:

$$P_{AC} = (46.9 \times 10^{-3}) \times (242/600) = 45.0 \text{ mW}$$
(4)

The maximum power dissipation allowed at a certain temperature is a function of maximum die junction temperature ( $T_{J(MAX)}$ ) allowed, ambient temperature  $T_A$ , and package thermal resistance from junction to ambient,  $\theta_{JA}$ .

$$P_{D(MAX)} = \frac{T_{J(MAX)} - T_A}{\theta_{JA}}$$
(5)

For the LM732xx, the maximum junction temperature allowed is 150°C at which no power dissipation is allowed. The power capability at 25°C is given by the following calculations:

For VSSOP package:

$$P_{D(MAX)} = \frac{150^\circ\text{C} - 25^\circ\text{C}}{235^\circ\text{C/W}} = 0.53 \text{ W}$$
(6)

For SOIC package:

$$P_{D(MAX)} = \frac{150^\circ\text{C} - 25^\circ\text{C}}{165^\circ\text{C/W}} = 0.76 \text{ W}$$
(7)

Similarly, the power capability at 125°C is given by:

For VSSOP package:

$$P_{D(MAX)} = \frac{150^\circ\text{C} - 125^\circ\text{C}}{235^\circ\text{C/W}} = 0.11 \text{ W}$$
(8)

For SOIC package:

$$P_{D(MAX)} = \frac{150^\circ\text{C} - 125^\circ\text{C}}{165^\circ\text{C/W}} = 0.15 \text{ W}$$
(9)

Figure 58 shows the power capability vs. temperature for VSSOP and SOIC packages. The area under the maximum thermal capability line is the operating area for the device. When the device works in the operating area where  $P_{TOTAL}$  is less than  $P_{D(MAX)}$ , the device junction temperature will remain below 150°C. If the intersection of ambient temperature and package power is above the maximum thermal capability line, the junction temperature will exceed 150°C and this should be strictly prohibited.

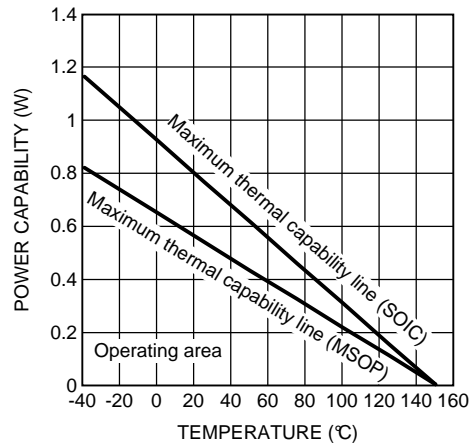


Figure 58. Power Capability vs. Temperature

When high power is required and ambient temperature can't be reduced, providing air flow is an effective approach to reduce thermal resistance therefore to improve power capability.

### 8.3.2 Estimating the Output Voltage Swing

It is important to keep in mind that the steady-state output current will be less than the current available when there is an input overdrive present. For steady-state conditions, the Output Voltage vs. Output Current plot (*Typical Characteristics* section) can be used to predict the output swing. Figure 59 and Figure 60 show this performance along with several load lines corresponding to loads tied between the output and ground. In each case, the intersection of the device plot at the appropriate temperature with the load line would be the typical output swing possible for that load. For example, a 1-kΩ load can accommodate an output swing to within 250 mV of  $V^-$  and to 330 mV of  $V^+$  ( $V_S = \pm 15\text{ V}$ ) corresponding to a typical 29.3  $V_{PP}$  unclipped swing.

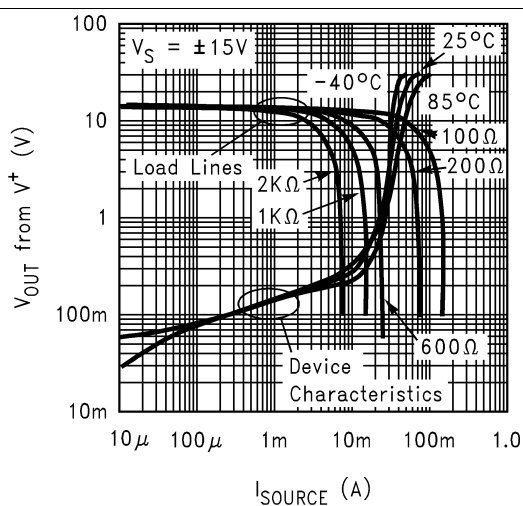


Figure 59. Output Sourcing Characteristics With Load Lines

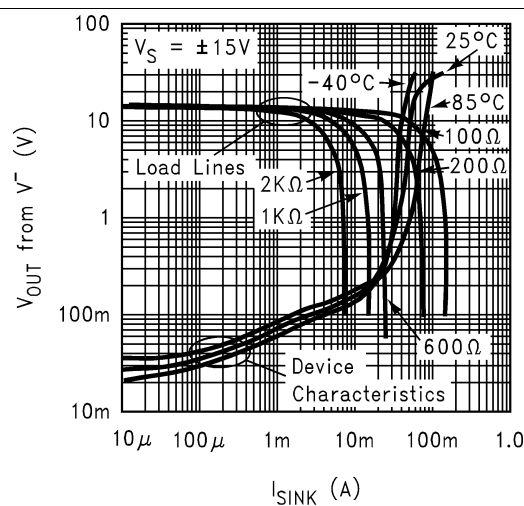


Figure 60. Output Sinking Characteristics With Load Lines

## 8.4 Device Functional Modes

### 8.4.1 Driving Capacitive Loads

The LM732xx are specifically designed to drive unlimited capacitive loads without oscillations as shown in Figure 61.

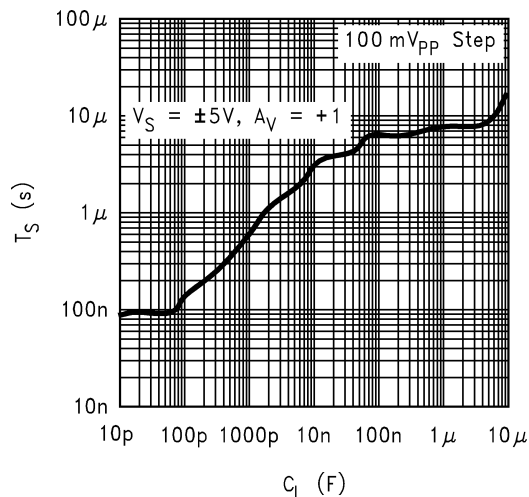


Figure 61. ±5% Settling Time vs. Capacitive Load

In addition, the output current handling capability of the device allows for good slewing characteristics even with large capacitive loads as shown in Figure 62 and Figure 63.

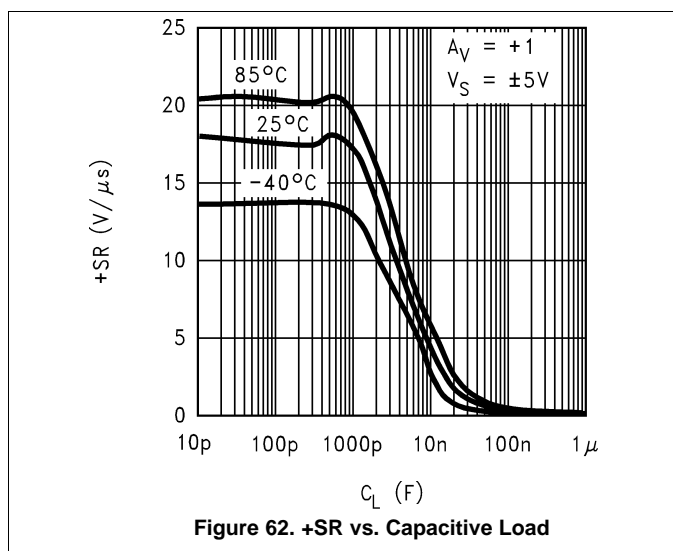


Figure 62. +SR vs. Capacitive Load

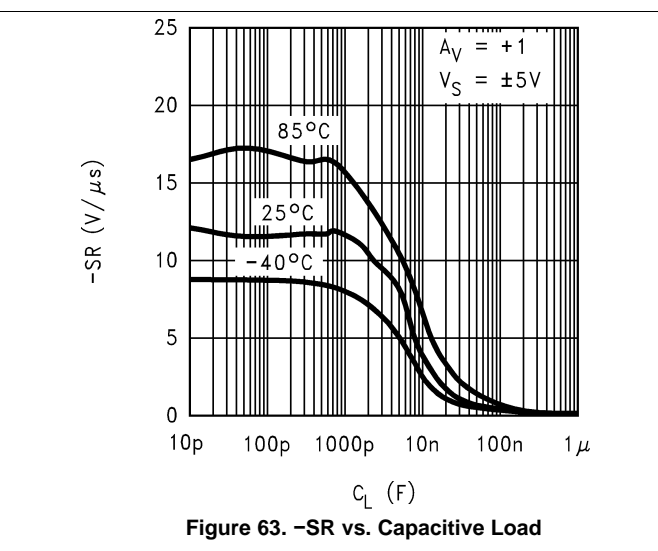


Figure 63. -SR vs. Capacitive Load

The combination of these features is ideal for applications such as TFT flat panel buffers, A/D converter input amplifiers, and so forth.

However, as in most op amps, addition of a series isolation resistor between the op amp and the capacitive load improves the settling and overshoot performance.

Output current drive is an important parameter when driving capacitive loads. This parameter will determine how fast the output voltage can change. Referring to the Slew Rate vs. Capacitive Load Plots (*Typical Characteristics* section), two distinct regions can be identified. Below about 10,000 pF, the output Slew Rate is solely determined by the compensation capacitor value of the op amp and available current into that capacitor. Beyond 10 nF, the Slew Rate is determined by the available output current of the op amp.

Device Functional Modes (continued)

NOTE

Because of the lower output sourcing current compared to the sinking one, the Slew Rate limit under heavy capacitive loading is determined by the positive transitions.

An estimate of positive and negative slew rates for loads larger than 100 nF can be made by dividing the short circuit current value by the capacitor.

For the LM732xx, the available output current increases with the input overdrive. Referring to Figure 64 and Figure 65, it can be seen that both sourcing and sinking short circuit current increase as input overdrive increases. In a closed-loop amplifier configuration, during transient conditions while the fed back output has not quite caught up with the input, there will be an overdrive imposed on the input allowing more output current than would normally be available under steady-state condition. Because of this feature, the output stage quiescent current of the op amp can be kept to a minimum, thereby reducing power consumption, while enabling the device to deliver large output current when the need arises (such as during transients).

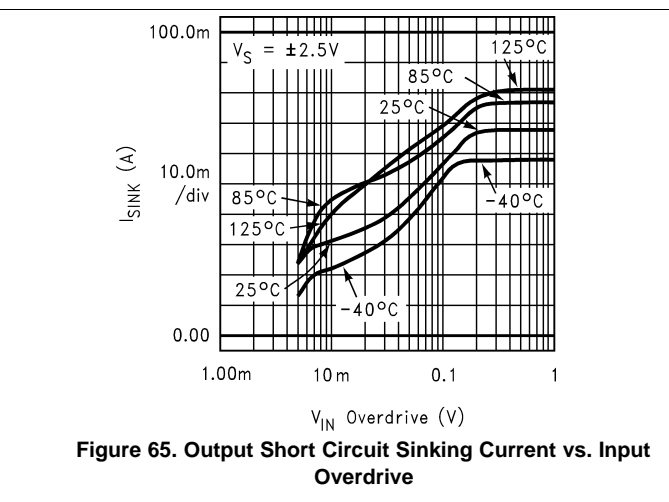
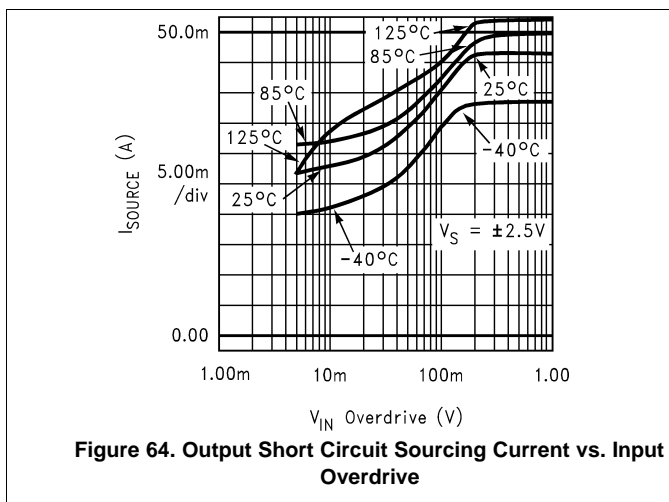
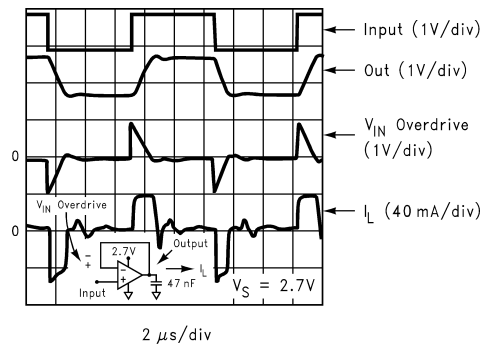


Figure 66 shows the output voltage, output current, and the resulting input overdrive with the device set for  $A_V = +1$  and the input tied to a  $1-V_{PP}$  step function driving a 47-nF capacitor. As can be seen, during the output transition, the input overdrive reaches 1-V peak and is more than enough to cause the output current to increase to its maximum value (see Figure 64 and Figure 65 plots).

NOTE

Because of the larger output sinking current compared to the sourcing one, the output negative transition is faster than the positive one.



## 9 Application and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

#### 9.1.1 Similar High-Output Devices

The LM7332 is a dual rail-to-rail amplifier with a slightly lower GBW capable of sinking and sourcing 100 mA. It is available in SOIC and VSSOP packages.

The LM4562 is dual op amp with very low noise and 0.7-mV voltage offset.

The LME49870 and LME49860 are single and dual low-noise amplifiers that can work from  $\pm 22$ -V supplies.

#### 9.1.2 Other High Performance SOT-23 Amplifiers

The LM7341 is a 4-MHz rail-to-rail input and output part that requires only 0.6 mA to operate, and can drive unlimited capacitive load. It has a voltage gain of 97 dB, a CMRR of 93 dB, and a PSRR of 104 dB.

The LM6211 is a 20-MHz part with CMOS input, which runs on  $\pm 12$ -V or 24-V single supplies. It has rail-to-rail output and low noise.

The LM7121 has a gain bandwidth of 235 MHz.

Detailed information on these parts can be found at [www.ti.com](http://www.ti.com).

### 9.2 Typical Application

Figure 67 shows a typical application where the LM732xx is used as a buffer amplifier for the  $V_{COM}$  signal employed in a TFT LCD flat panel:

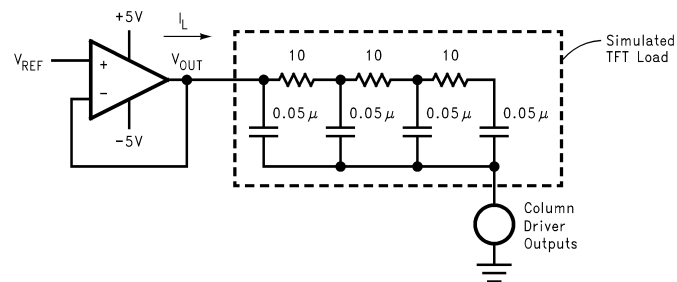


Figure 67.  $V_{COM}$  Driver Application Schematic

#### 9.2.1 Design Requirements

For this example application, the supply voltage is +5 V, and noninverting gain is necessary.

## Typical Application (continued)

### 9.2.2 Detailed Design Procedure

Figure 68 shows the time domain response of the amplifier when used as a  $V_{COM}$  buffer/driver with  $V_{REF}$  at ground. In this application, the op amp loop will try and maintain its output voltage based on the voltage on its noninverting input ( $V_{REF}$ ) despite the current injected into the TFT simulated load. As long as this load current is within the range tolerable by the LM732xx (45-mA sourcing and 65-mA sinking for  $\pm 5$ -V supplies), the output will settle to its final value within less than 2  $\mu$ s.

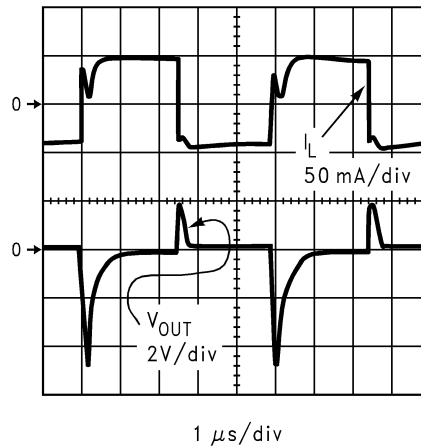


Figure 68.  $V_{COM}$  Driver Performance Scope Photo

### 9.2.3 Application Curve

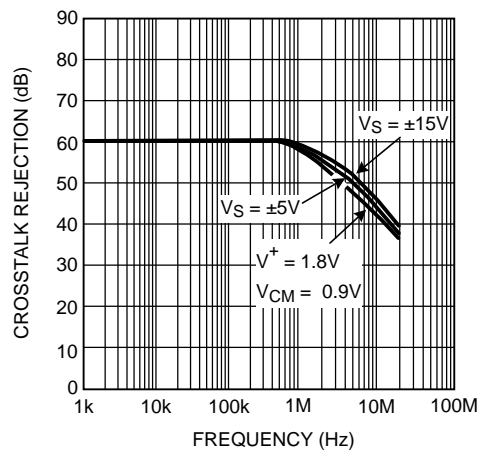


Figure 69. Crosstalk Rejection vs. Frequency

## 10 Power Supply Recommendations

The use of supply decoupling is mandatory in most applications. As with most relatively high-speed or high-output current op amps, best results are achieved when each supply line is decoupled with two capacitors; a small value ceramic capacitor ( about 0.01  $\mu\text{F}$ ) placed very close to the supply lead in addition to a large value Tantalum or Aluminum ( $> 4.7 \mu\text{F}$ ). The large capacitor can be shared by more than one device if necessary. The small ceramic capacitor maintains low supply impedance at high frequencies while the large capacitor will act as the charge *bucket* for fast load current spikes at the op amp output. The combination of these capacitors will provide supply decoupling and will help keep the op amp oscillation free under any load.

## 11 Layout

### 11.1 Layout Guidelines

Take care to minimize the loop area formed by the bypass capacitor connection between supply pins and ground. A ground plane underneath the device is recommended; any bypass components to ground should have a nearby via to the ground plane. The optimum bypass capacitor placement is closest to the corresponding supply pin. Use of thicker traces from the bypass capacitors to the corresponding supply pins will lower the power supply inductance and provide a more stable power supply.

The feedback components should be placed as close to the device as possible to minimize stray parasitics.

### 11.2 Layout Example

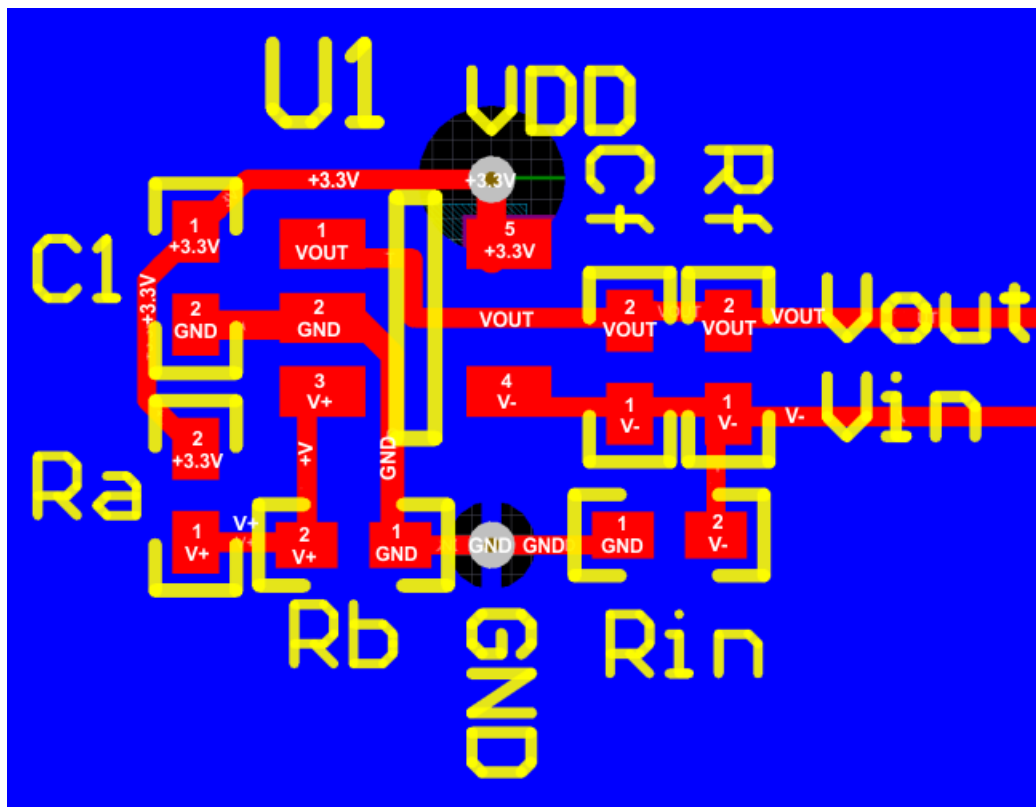


Figure 70. LM732xx Layout Example

## 12 Device and Documentation Support

### 12.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

**Table 2. Related Links**

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
LM7321	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>
LM7322	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>

### 12.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At [e2e.ti.com](http://e2e.ti.com), you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 12.3 Trademarks

E2E is a trademark of Texas Instruments.  
All other trademarks are the property of their respective owners.

### 12.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 12.5 Glossary

**SLYZ022** — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LM7321MA/NOPB	ACTIVE	SOIC	D	8	95	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LM7321MA	<a href="#">Samples</a>
LM7321MAX/NOPB	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LM7321MA	<a href="#">Samples</a>
LM7321MF/NOPB	ACTIVE	SOT-23	DBV	5	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AU4A	<a href="#">Samples</a>
LM7321MFE/NOPB	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AU4A	<a href="#">Samples</a>
LM7321MFX/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AU4A	<a href="#">Samples</a>
LM7321QMF/NOPB	ACTIVE	SOT-23	DBV	5	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AR8A	<a href="#">Samples</a>
LM7321QMFE/NOPB	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AR8A	<a href="#">Samples</a>
LM7321QMFX/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AR8A	<a href="#">Samples</a>
LM7322MA/NOPB	ACTIVE	SOIC	D	8	95	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LM7322MA	<a href="#">Samples</a>
LM7322MAX/NOPB	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LM7322MA	<a href="#">Samples</a>
LM7322MM/NOPB	ACTIVE	VSSOP	DGK	8	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AZ4A	<a href="#">Samples</a>
LM7322MME/NOPB	ACTIVE	VSSOP	DGK	8	250	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	AZ4A	<a href="#">Samples</a>
LM7322QMA/NOPB	ACTIVE	SOIC	D	8	95	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LM7322QMA	<a href="#">Samples</a>
LM7322QMAX/NOPB	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LM7322QMA	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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**OTHER QUALIFIED VERSIONS OF LM7321, LM7321-Q1, LM7322, LM7322-Q1 :**

● Catalog: [LM7321](#), [LM7322](#)

● Automotive: [LM7321-Q1](#), [LM7322-Q1](#)

NOTE: Qualified Version Definitions:

● Catalog - TI's standard catalog product

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## TAPE AND REEL INFORMATION

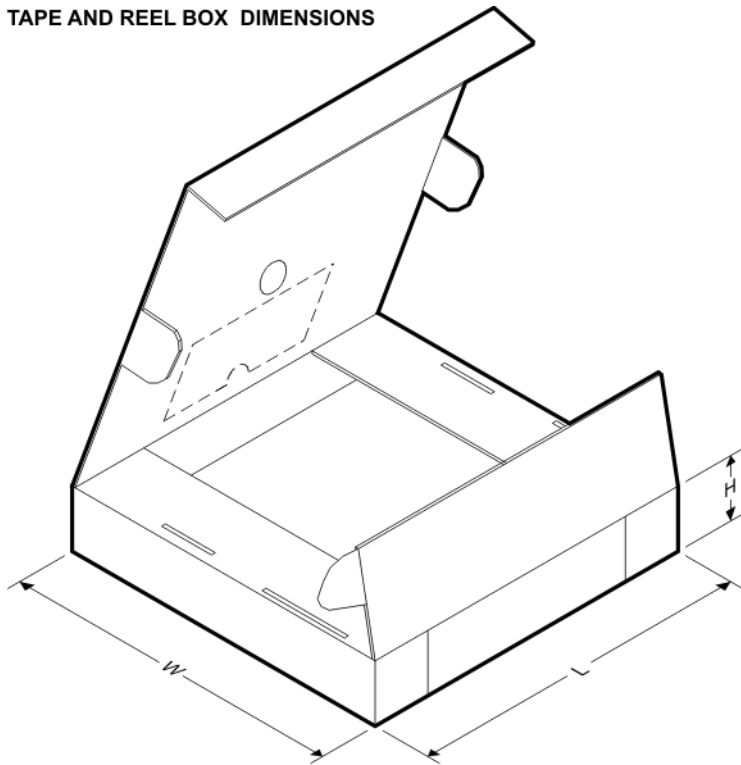


### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LM7321MAX/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LM7321MF/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LM7321MFE/NOPB	SOT-23	DBV	5	250	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LM7321MFX/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LM7321QMF/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LM7321QMFE/NOPB	SOT-23	DBV	5	250	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LM7321QMFN/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LM7322MAX/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LM7322MM/NOPB	VSSOP	DGK	8	1000	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LM7322MME/NOPB	VSSOP	DGK	8	250	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LM7322QMAX/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1

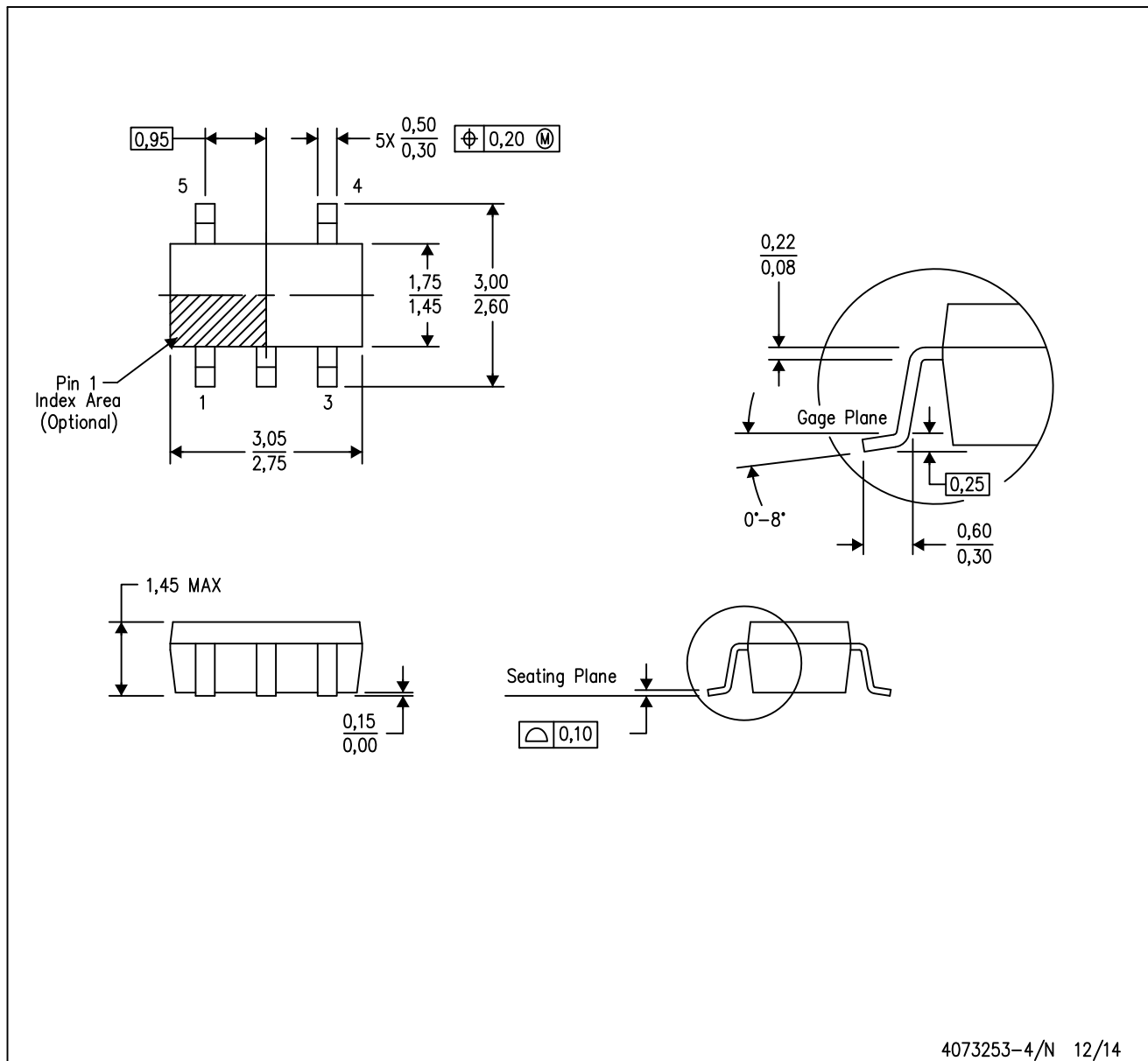
**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LM7321MAX/NOPB	SOIC	D	8	2500	367.0	367.0	35.0
LM7321MF/NOPB	SOT-23	DBV	5	1000	210.0	185.0	35.0
LM7321MFE/NOPB	SOT-23	DBV	5	250	210.0	185.0	35.0
LM7321MFX/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LM7321QMF/NOPB	SOT-23	DBV	5	1000	210.0	185.0	35.0
LM7321QMFE/NOPB	SOT-23	DBV	5	250	210.0	185.0	35.0
LM7321QMFX/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LM7322MAX/NOPB	SOIC	D	8	2500	367.0	367.0	35.0
LM7322MM/NOPB	VSSOP	DGK	8	1000	210.0	185.0	35.0
LM7322MME/NOPB	VSSOP	DGK	8	250	210.0	185.0	35.0
LM7322QMAX/NOPB	SOIC	D	8	2500	367.0	367.0	35.0

DBV (R-PDSO-G5)

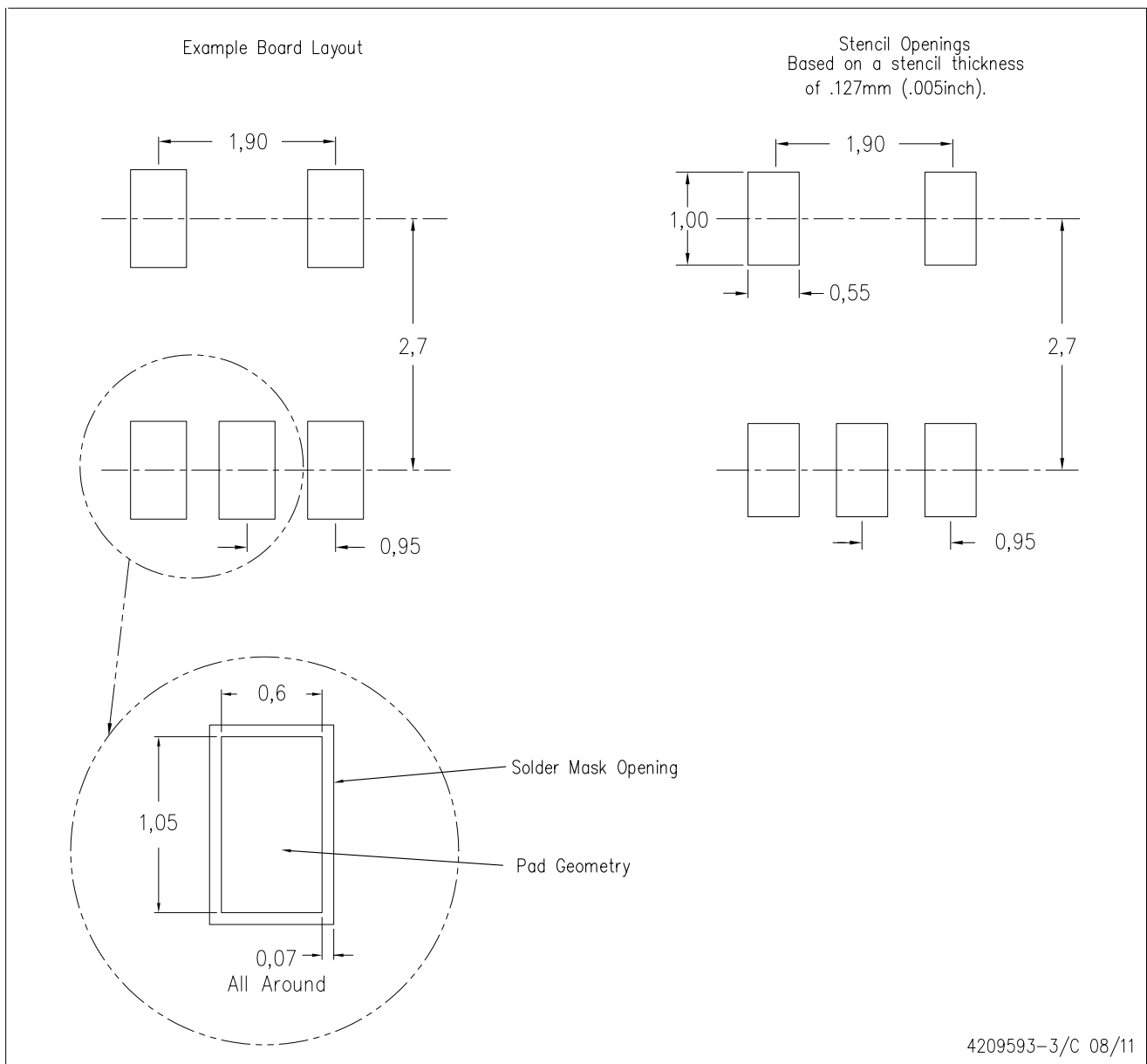
PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
  - D. Falls within JEDEC MO-178 Variation AA.

DBV (R-PDSO-G5)

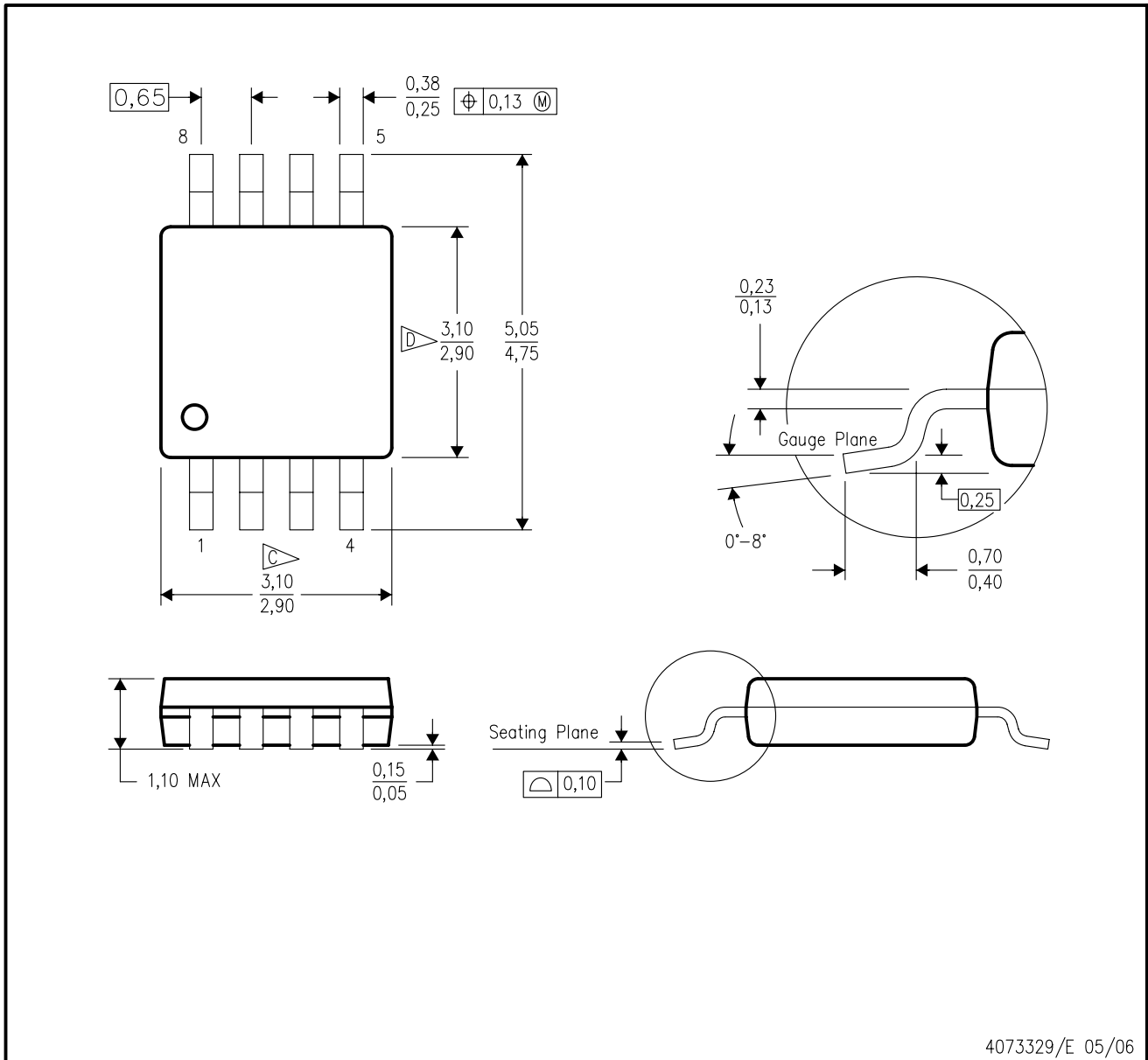
PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
  - D. Publication IPC-7351 is recommended for alternate designs.
  - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.

DGK (S-PDSO-G8)

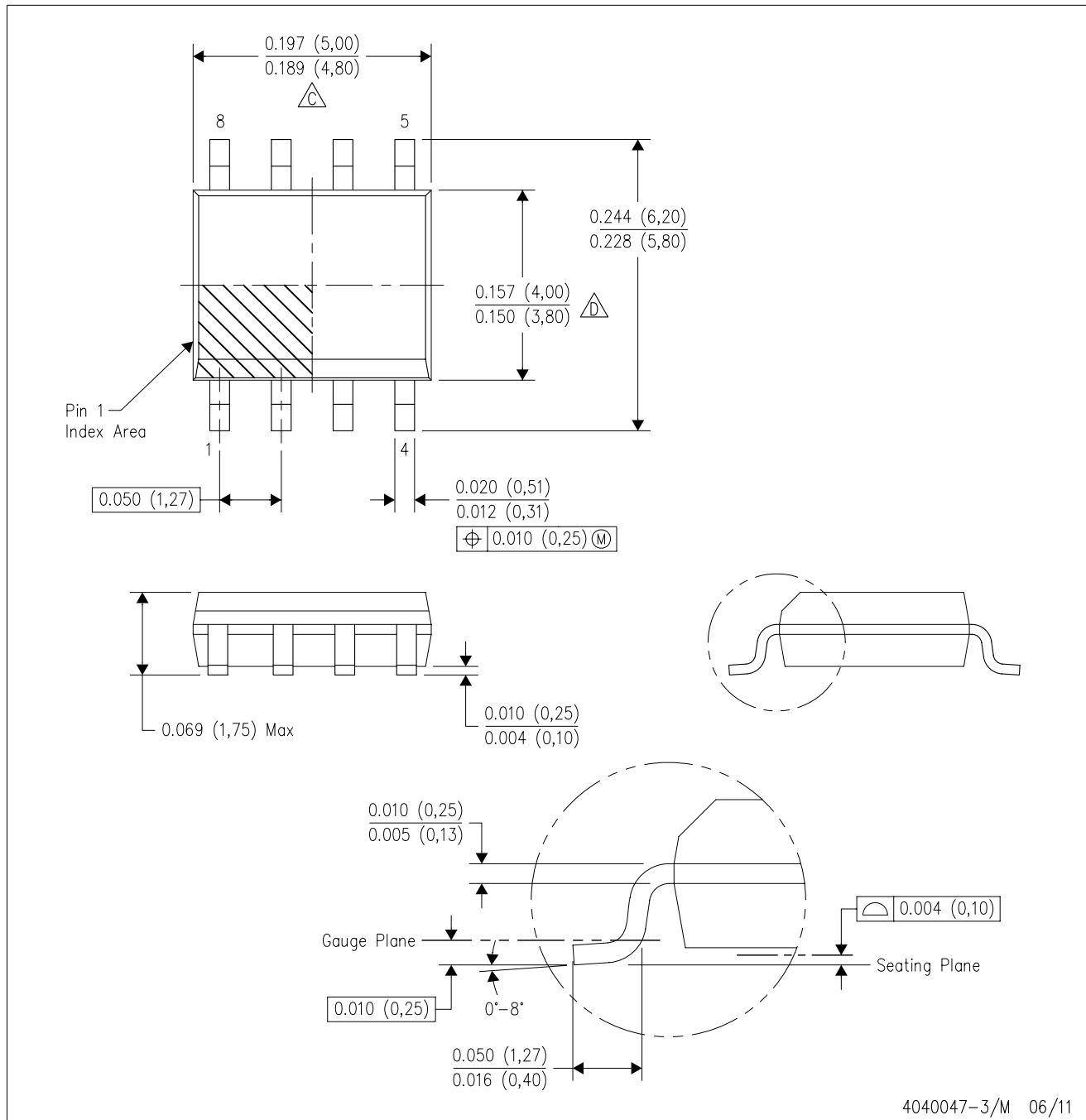
PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
  - D. Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
  - E. Falls within JEDEC MO-187 variation AA, except interlead flash.

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



4040047-3/M 06/11

- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
  - Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
  - E. Reference JEDEC MS-012 variation AA.

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